MACH 4 CPLD Family

High Performance EE CMOS Programmable Logic

Includes MACH 4A Family Advance Information
M4A-32/32 and M4A-128/64 Preliminary Information

FEATURES

- **High-performance, EE CMOS 3.3-V & 5-V CPLD families**
- **Flexible architecture for rapid logic designs**
  - — Excellent First-Time-Fit™ and refit feature
  - — SpeedLocking™ performance for guaranteed fixed timing
  - — Central, input and output switch matrices for 100% routability and 100% pin-out retention
- **High speed**
  - — 5.0ns t_{PD} Commercial and 7.5ns t_{PD} Industrial
  - — 182MHz f_{CNT}
- **32 to 512 macrocells; 32 to 768 registers**
- **44 to 352 pins in PLCC, PQFP, TQFP, BGA, fpBGA or caBGA packages**
- **Flexible architecture for a wide range of design styles**
  - — D/T registers and latches
  - — Synchronous or asynchronous mode
  - — Dedicated input registers
  - — Programmable polarity
  - — Reset/ preset swapping
- **Advanced capabilities for easy system integration**
  - — 3.3-V & 5-V JEDEC-compliant operations
  - — JTAG (IEEE 1149.1) compliant for boundary scan testing
  - — 3.3-V & 5-V JTAG in-system programming
  - — PCI compliant (-5/-55/-65/-7/-10/-12 speed grades)
  - — Safe for mixed supply voltage system designs
  - — Programmable pull-up or Bus-Friendly™ inputs and I/Os
  - — Hot-socketing
  - — Programmable security bit
  - — Individual output slew rate control
- **Advanced EE CMOS process provides high-performance, cost-effective solutions**
- **Supported by ispDesignEXPERT™ software for rapid logic development**
  - — Supports HDL design methodologies with results optimized for MACH 4A
  - — Flexibility to adapt to user requirements
  - — Software partnerships that ensure customer success
- **Lattice/Vantis and third-party hardware programming support**
  - — Lattice/VantisPRO™ (formerly known as MACHPRO®) software for in-system programmability support on PCs and automated test equipment
  - — Programming support on all major programmers including Data I/O, BP Microsystems, Advin, and System General

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Table 1. MACH 4 Device Features[1,2]

Feature	M4-32/32 M4LV-32/32	M4-64/32 M4LV-64/32	M4-96/48 M4LV-96/48	M4-128/64 M4LV-128/64	M4-128N/64 M4LV-128N/64	M4-192/96 M4LV-192/96	M4-256/128 M4LV-256/128
Macrocells	32	64	96	128	128	192	256
Maximum User I/O Pins	32	32	48	64	64	96	128
t_{PD} (ns)	7.5	7.5	7.5	7.5	7.5	7.5	7.5
f_{CNT} (MHz)	111	111	111	111	111	111	111
t_{COS} (ns)	5.5	5.5	5.5	5.5	5.5	5.5	5.5
t_{SS} (ns)	5.5	5.5	5.5	5.5	5.5	5.5	5.5
Static Power (mA)	25	25	50	70	70	85	100
JTAG Compliant	Yes	Yes	Yes	Yes	No	Yes	Yes
PCI Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes

Notes:

1. *For information on the M4-96/96 device, please refer to the M4-96/96 datasheet at www.latticesemi.com.*
2. *"M4-xxx" is for 5-V devices. "M4LV-xxx" is for 3.3-V devices.*

Table 2. MACH 4A Device Features

3.3 V Devices								
Feature	**M4A3-32[2]**	**M4A3-64[1]**	**M4A3-96[1]**	**M4A3-128[2]**	**M4A3-192[1]**	**M4A3-256[1]**	**M4A3-384[1]**	**M4A3-512[1]**
Macrocells	32	64	96	128	192	256	384	512
User I/O options	32	32	48	64	96	128/160/192	132/160/192	132/160/192/256
t_{PD} (ns)	5.0	5.5	5.5	5.5	6.5	6.5	7.5	7.5
f_{CNT} (MHz)	182	167	167	167	154	154	125	125
t_{COS} (ns)	4.0	4.0	4.0	4.0	4.5	4.5	5.0	5.0
t_{SS} (ns)	3.0	3.5	3.5	3.5	4.0	4.0	5.5	5.5
Static Power (mA)	20	TBD	TBD	55	TBD	TBD	TBD	TBD
JTAG Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
PCI Compliant	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes

5 V Devices						
Feature	**M4A5-32[2]**	**M4A5-64[1]**	**M4A5-96[1]**	**M4A5-128[2]**	**M4A5-192[1]**	**M4A5-256[1]**
Macrocells	32	64	96	128	192	256
User I/O options	32	32	48	64	96	128
t_{PD} (ns)	5.0	5.5	5.5	5.5	6.5	6.5
f_{CNT} (MHz)	182	167	167	167	154	154
t_{COS} (ns)	4.0	4.0	4.0	4.0	4.5	4.5
t_{SS} (ns)	3.0	3.5	3.5	3.5	4.0	4.0
Static Power (mA)	20	TBD	TBD	55	TBD	TBD
JTAG Compliant	Yes	Yes	Yes	Yes	Yes	Yes
PCI Compliant	Yes	Yes	Yes	Yes	Yes	Yes

Notes:

1. *Advance information is shaded. Please contact a Lattice/Vantis sales representative for details on availability.*
2. *Preliminary information.*

GENERAL DESCRIPTION

The MACH® 4 family from Lattice/Vantis offers an exceptionally flexible architecture and delivers a superior Complex Programmable Logic Device (CPLD) solution of easy-to-use silicon products and software tools. The overall benefits for users are a guaranteed and predictable CPLD solution, faster time-to-market, greater flexibility and lower cost. The MACH 4 devices offer densities ranging from 32 to 512 macrocells with 100% utilization and 100% pin-out retention. Both the MACH 4 and the MACH 4A families offer 5-V (M4-xxx and M4A5-xxx) and 3.3-V (M4LV-xxx and M4A3-xxx) operation.

MACH 4 products are 5-V or 3.3-V in-system programmable through the JTAG (IEEE Std. 1149.1) interface. JTAG boundary scan testing also allows product testability on automated test equipment for device connectivity.

All MACH 4 family members deliver First-Time-Fit and easy system integration with pin-out retention after any design change and refit. For both 3.3-V and 5-V operation, MACH 4 products can deliver guaranteed fixed timing as fast as 5.0 ns t_{PD} and 182 MHz f_{CNT} through the SpeedLocking feature when using up to 20 product terms per output (Tables 3 and 4).

Table 3. MACH 4 Speed Grades

Device	Speed Grade[1]					
	-7	-10	-12	-14	-15	-18
M4-32/32 M4LV-32/32	C	C, I	C, I	I	C	I
M4-64/32 M4LV-64/32	C	C, I	C, I	I	C	I
M4-96/48 M4LV-96/48	C	C, I	C, I	I	C	I
M4-128/64 M4LV-128/64	C	C, I	C, I	I	C	I
M4-128N/64 M4LV-128N/64	C	C, I	C, I	I	C	I
M4-192/96 M4LV-192/96	C	C, I	C, I	I	C	I
M4-256/128 M4LV-256/128	C	C, I	C, I	I	C	I

Note:

1. C = Commercial, I = Industrial

Table 4. MACH 4A Speed Grades

Device	Speed Grade						
	-5	-55	-65	-7	-10	-12	-14
M4A3-32[3] M4A5-32[3]	C			C, I	C, I	I	
M4A3-64[2] M4A5-64[2]		C		C, I	C, I	I	
M4A3-96[2] M4A5-96[2]		C		C, I	C, I	I	
M4A3-128[3] M4A5-128[3]		C		C, I	C, I	I	
M4A3-192[2] M4A5-192[2]			C	C	C, I	I	
M4A3-256[2] M4A5-256[2]			C	C	C, I	I	
M4A3-384[2]				C	C, I	C, I	I
M4A3-512[2]				C	C, I	C, I	I

Notes:

1. *C = Commercial, I = Industrial*
2. *Advance information is shaded. Please contact a Lattice/Vantis sales representative for details on availability.*
3. *Preliminary information.*

The MACH 4 family offers 20 density-I/O combinations in Thin Quad Flat Pack (TQFP), Plastic Quad Flat Pack (PQFP), Plastic Leaded Chip Carrier (PLCC), Ball Grid Array (BGA), fine-pitch BGA (fpBGA), and chip-array BGA (caBGA) packages ranging from 44 to 352 pins (Tables 5 and 6). It also offers I/O safety features for mixed-voltage designs so that the 3.3-V devices can accept 5-V inputs, and 5-V devices do not overdrive 3.3-V inputs. Additional features include Bus-Friendly inputs and I/Os, a programmable power-down mode for extra power savings and individual output slew rate control for the highest speed transition or for the lowest noise transition.

Table 5. MACH 4 Package and I/O Options (Number of I/Os and dedicated inputs in Table)

Package	M4-32/32 M4LV-32/32	M4-64/32 M4LV-64/32	M4-96/48 M4LV-96/48	M4-128/64 M4LV-128/64	M4-128N/64 M4LV-128N/64	M4-192/96 M4LV-192/96	M4-256/128 M4LV-256/128
44-pin PLCC	32+2	32+2					
44-pin TQFP	32+2	32+2					
48-pin TQFP	32+2	32+2					
84-pin PLCC					64+6		
100-pin TQFP			48+8	64+6			
100-pin PQFP				64+6			
144-pin TQFP						96+16	
208-pin PQFP							128+14
256-ball BGA							128+14

Table 6. MACH 4A Package and I/O Options (Number of I/Os and dedicated inputs in Table)

3.3 V Devices								
Package	**M4A3-32[2]**	**M4A3-64[1]**	**M4A3-96**	**M4A3-128**	**M4A3-192[1]**	**M4A3-256[1]**	**M4A3-384[1]**	**M4A3-512[1]**
44-pin PLCC	32+2	32+2						
44-pin TQFP	32+2	32+2						
48-pin TQFP	32+2	32+2						
100-pin TQFP			48+8	64+6[2]				
100-pin PQFP				64+6[2]				
100-ball caBGA				64+6[1]				
144-pin TQFP					96+16			
144-ball fpBGA					96+16			
176-pin TQFP						128+4	132	132
208-ball fpBGA						128+4		
208-pin PQFP						128+14, 160	160	160
256-ball fpBGA						192		192
256-ball BGA						128+14	192	
388-ball fpBGA								256

5 V Devices						
Package	**M4A5-32[2]**	**M4A5-64[1]**	**M4A5-96[1]**	**M4A5-128[2]**	**M4A5-192[1]**	**M4A5-256[1]**
44-pin PLCC	32+2	32+2				
44-pin TQFP	32+2	32+2				
48-pin TQFP	32+2	32+2				
100-pin TQFP			48+8	64+6		
100-pin PQFP				64+6		
144-pin TQFP					96+16	
208-pin PQFP						128+14
256-ball BGA						128+14

Note:

1. *Advance information is shaded. Please contact a Lattice/Vantis sales representative for details on availability.*
2. *Preliminary information.*

FUNCTIONAL DESCRIPTION

The fundamental architecture of MACH 4 devices (Figure 1) consists of multiple, optimized PAL® blocks interconnected by a central switch matrix. The central switch matrix allows communication between PAL blocks and routes inputs to the PAL blocks. Together, the PAL blocks and central switch matrix allow the logic designer to create large designs in a single device instead of having to use multiple devices.

The key to being able to make effective use of these devices lies in the interconnect schemes. In MACH 4 architecture, the macrocells are flexibly coupled to the product terms through the logic allocator, and the I/O pins are flexibly coupled to the macrocells due to the output switch matrix. In addition, more input routing options are provided by the input switch matrix. These resources provide the flexibility needed to fit designs efficiently.

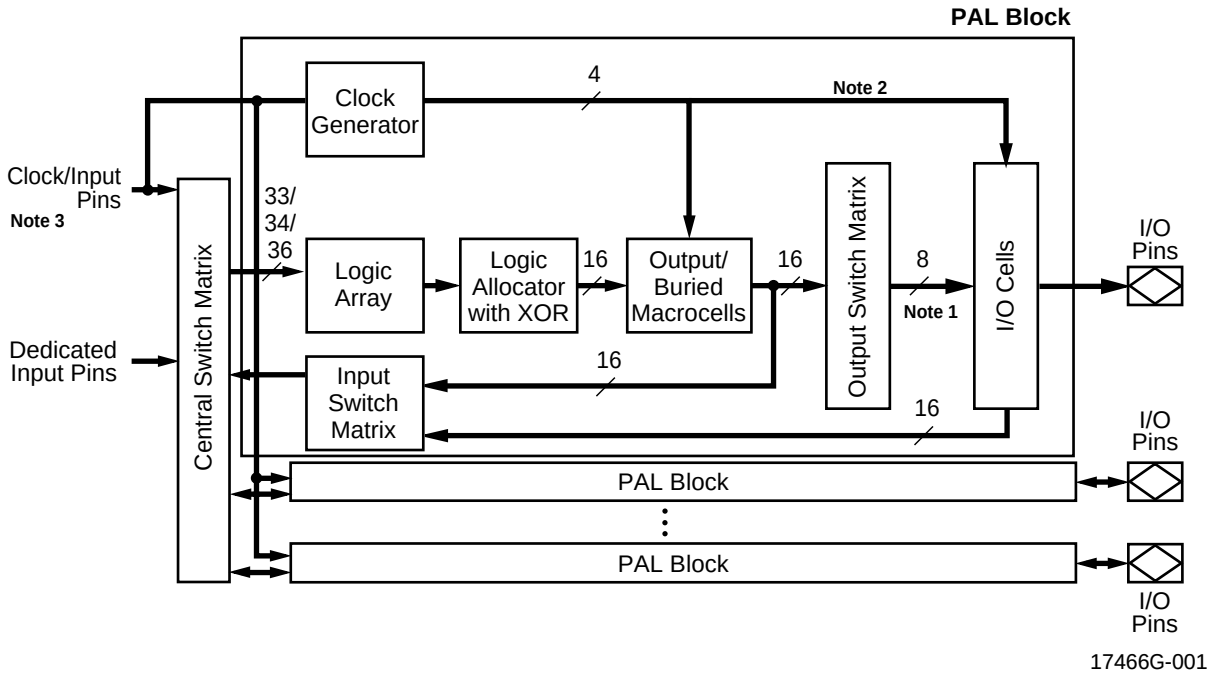


Figure 1. MACH 4 Block Diagram and PAL Block Structure

Notes:

1. *16 for MACH 4 and MACH 4A devices with 1:1 macrocell-I/O cell ratio (see next page).*
2. *Block clocks do not go to I/O cells in M4(LV)-32/32 or M4A(3,5)-32/32.*
3. *M4(LV)-192/96, M4(LV)-256/128, M4A(3,5)-192, M4A(3,5)-256, M4A3-384, and M4A3-512 have dedicated clock pins which cannot be used as inputs and do not connect to the central switch matrix.*

Table 7. Architectural Summary of MACH 4 devices

	MACH 4A Devices	
	M4-64/32, M4LV-64/32 M4-96/48, M4LV-96/48 M4-128/64, M4LV-128/64 M4-128N/64, M4LV-128N/64 M4-192/96, M4LV-192/96 M4-256/128, M4LV-256/128	M4-32/32 M4LV-32/32
Macrocell-I/O Cell Ratio	2:1	1:1
Input Switch Matrix	Yes	Yes
Input Registers	Yes	No
Central Switch Matrix	Yes	Yes
Output Switch Matrix	Yes	Yes

Table 8. Architectural Summary of MACH 4A devices

	MACH 4A Devices	
	M4A3-64/32, M4A5-64/32 M4A3-96/48, M4A5-96/48 M4A3-128/64, M4A5-128/64 M4A3-192/96, M4A5-192/96 M4A3-256/128, M4A5-256/128 M4A3-384 M4A3-512	M4A3-32/32 M4A5-32/32 M4A3-256/160 M4A3-256/192
Macrocell-I/O Cell Ratio	2:1	1:1
Input Switch Matrix	Yes	Yes
Input Registers	Yes	No
Central Switch Matrix	Yes	Yes
Output Switch Matrix	Yes	Yes

The Macrocell-I/O cell ratio is defined as the number of macrocells versus the number of I/O cells internally in a PAL block (Tables 7 and 8).

The central switch matrix takes all dedicated inputs and signals from the input switch matrices and routes them as needed to the PAL blocks. Feedback signals that return to the same PAL block still must go through the central switch matrix. This mechanism ensures that PAL blocks in MACH 4 devices communicate with each other with consistent, predictable delays.

The central switch matrix makes a MACH 4 device more advanced than simply several PAL devices on a single chip. It allows the designer to think of the device not as a collection of blocks, but as a single programmable device; the software partitions the design into PAL blocks through the central switch matrix so that the designer does not have to be concerned with the internal architecture of the device.

Each PAL block consists of:

- Product-term array
- Logic allocator
- Macrocells
- Output switch matrix
- I/O cells
- Input switch matrix
- Clock generator

Product-Term Array

The product-term array consists of a number of product terms that form the basis of the logic being implemented. The inputs to the AND gates come from the central switch matrix (Table 9), and are provided in both true and complement forms for efficient logic implementation.

Table 9. PAL Block Inputs

Device	Number of Inputs to PAL Block
M4-32/32 and M4LV-32/32	33
M4-64/32 and M4LV-64/32	33
M4-96/48 and M4LV-96/48	33
M4-128/64 and M4LV-128/64	33
M4-128N/64 and M4LV-128N/64	33
M4-192/96 and M4LV-192/96	34
M4-256/128 and M4LV-256/128	34
M4A3-32/32 and M4A5-32/32	33
M4A3-64/32 and M4A5-64/32	33
M4A3-96/48 and M4A5-96/48	33
M4A3-128/64 and M4A5-128/64	33
M4A3-192/96 and M4A5-192/96	34
M4A3-256/128 and M4A5-256/128	34
M4A3-256/160 and M4A3-256/192	36
M4A3-384	36
M4A3-512	36

Logic Allocator

Within the logic allocator, product terms are allocated to macrocells in “product term clusters.” The availability and distribution of product term clusters are automatically considered by the software as it fits functions within a PAL block. The size of a product term cluster has been optimized to provide high utilization of product terms, making complex functions using many product terms possible. Yet when few product terms are used, there will be a minimal number of unused—or wasted—product terms left over. The product term clusters available to each macrocell within a PAL block are shown in Tables 10 and 11.

Each product term cluster is associated with a macrocell. The size of a cluster depends on the configuration of the associated macrocell. When the macrocell is used in synchronous mode (Figure 2a), the basic cluster has 4 product terms. When the associated macrocell is used in asynchronous mode (Figure 2b), the cluster has 2 product terms. Note that if the product term cluster is routed to a different macrocell, the allocator configuration is not determined by the

mode of the macrocell actually being driven. The configuration is always set by the mode of the macrocell that the cluster will drive if not routed away, regardless of the actual routing.

In addition, there is an extra product term that can either join the basic cluster to give an extended cluster, or drive the second input of an exclusive-OR gate in the signal path. If included with the basic cluster, this provides for up to 20 product terms on a synchronous function that uses four extended 5-product-term clusters. A similar asynchronous function can have up to 18 product terms.

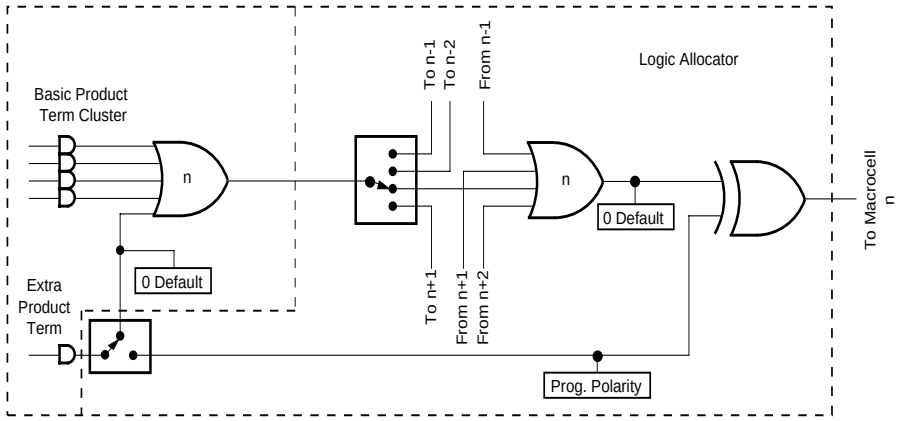
When the extra product term is used to extend the cluster, the value of the second XOR input can be programmed as a 0 or a 1, giving polarity control. The possible configurations of the logic allocator are shown in Figures 3 and 4.

Table 10. Logic Allocator for All MACH 4 and MACH 4A Devices (except M4(LV)-32/32 and M4A(3,5)-32/32)

Output Macrocell	Available Clusters	Output Macrocell	Available Clusters
M_0	C_0, C_1, C_2	M_8	C_7, C_8, C_9, C_{10}
M_1	C_0, C_1, C_2, C_3	M_9	C_8, C_9, C_{10}, C_{11}
M_2	C_1, C_2, C_3, C_4	M_{10}	$C_9, C_{10}, C_{11}, C_{12}$
M_3	C_2, C_3, C_4, C_5	M_{11}	$C_{10}, C_{11}, C_{12}, C_{13}$
M_4	C_3, C_4, C_5, C_6	M_{12}	$C_{11}, C_{12}, C_{13}, C_{14}$
M_5	C_4, C_5, C_6, C_7	M_{13}	$C_{12}, C_{13}, C_{14}, C_{15}$
M_6	C_5, C_6, C_7, C_8	M_{14}	C_{13}, C_{14}, C_{15}
M_7	C_6, C_7, C_8, C_9	M_{15}	C_{14}, C_{15}

Table 11. Logic Allocator for M4(LV)-32/32 and M4A(3,5)-32/32

Output Macrocell	Available Clusters	Output Macrocell	Available Clusters
M_0	C_0, C_1, C_2	M_8	C_8, C_9, C_{10}
M_1	C_0, C_1, C_2, C_3	M_9	C_8, C_9, C_{10}, C_{11}
M_2	C_1, C_2, C_3, C_4	M_{10}	$C_9, C_{10}, C_{11}, C_{12}$
M_3	C_2, C_3, C_4, C_5	M_{11}	$C_{10}, C_{11}, C_{12}, C_{13}$
M_4	C_3, C_4, C_5, C_6	M_{12}	$C_{11}, C_{12}, C_{13}, C_{14}$
M_5	C_4, C_5, C_6, C_7	M_{13}	$C_{12}, C_{13}, C_{14}, C_{15}$
M_6	C_5, C_6, C_7	M_{14}	C_{13}, C_{14}, C_{15}
M_7	C_6, C_7	M_{15}	C_{14}, C_{15}



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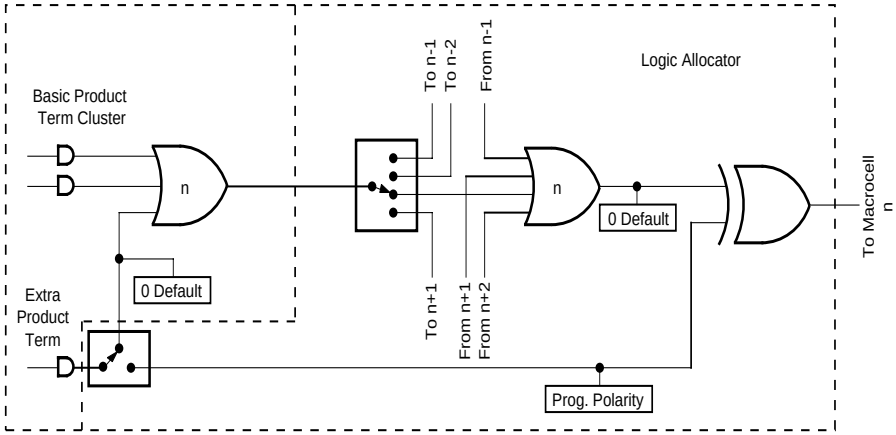
a. Synchronous Mode



b. Asynchronous Mode

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Figure 2. Logic Allocator: Configuration of Cluster "n" Set by Mode of Macrocell "n"

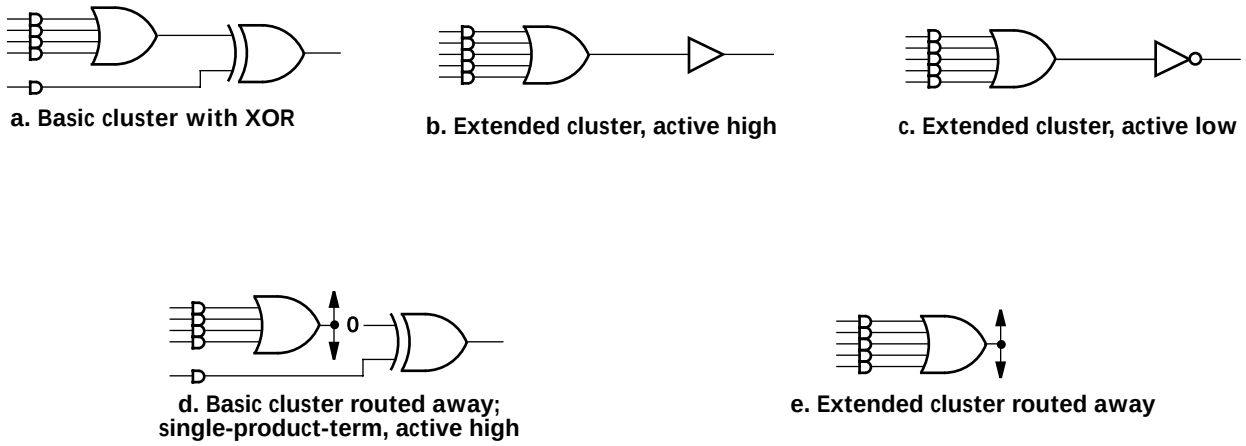

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Figure 3. Logic Allocator Configurations: Synchronous Mode

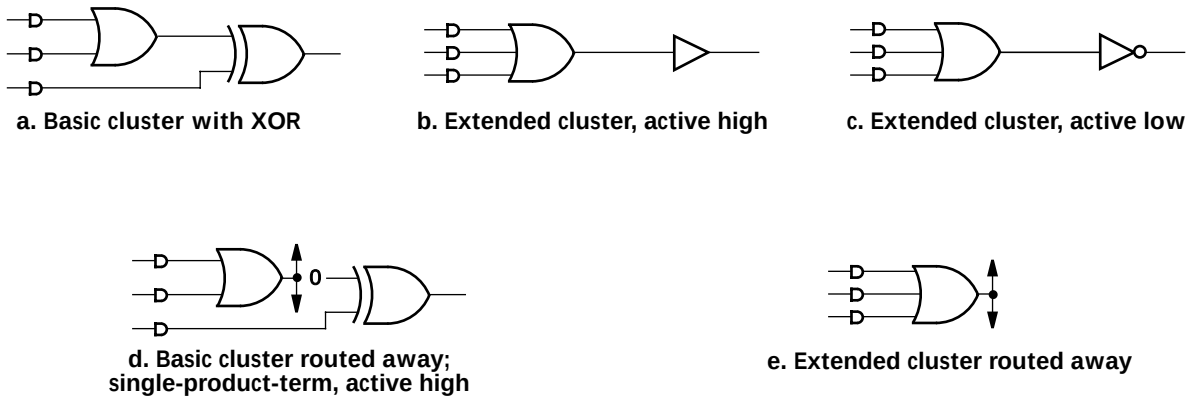

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Figure 4. Logic Allocator Configurations: Asynchronous Mode

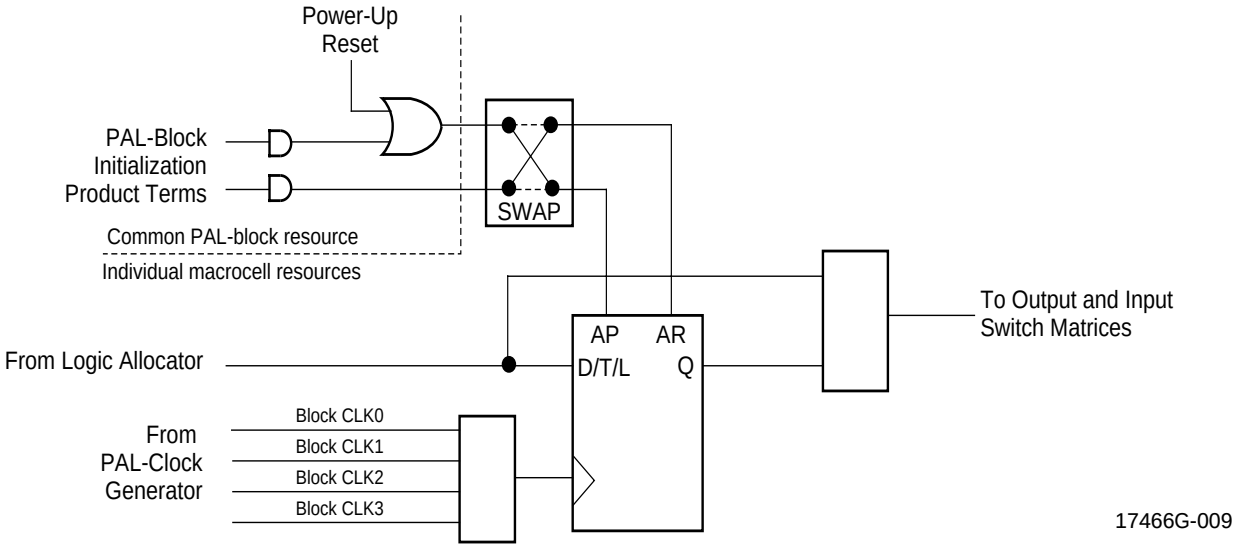
Note that the configuration of the logic allocator has absolutely no impact on the speed of the signal. All configurations have the same delay. This means that designers do not have to decide between optimizing resources or speed; both can be optimized.

If not used in the cluster, the extra product term can act in conjunction with the basic cluster to provide XOR logic for such functions as data comparison, or it can work with the D-,T-type flip-flop to provide for J-K, and S-R register operation. In addition, if the basic cluster is routed to another macrocell, the extra product term is still available for logic. In this case, the first XOR input will be a logic 0. This circuit has the flexibility to route product terms elsewhere without giving up the use of the macrocell.

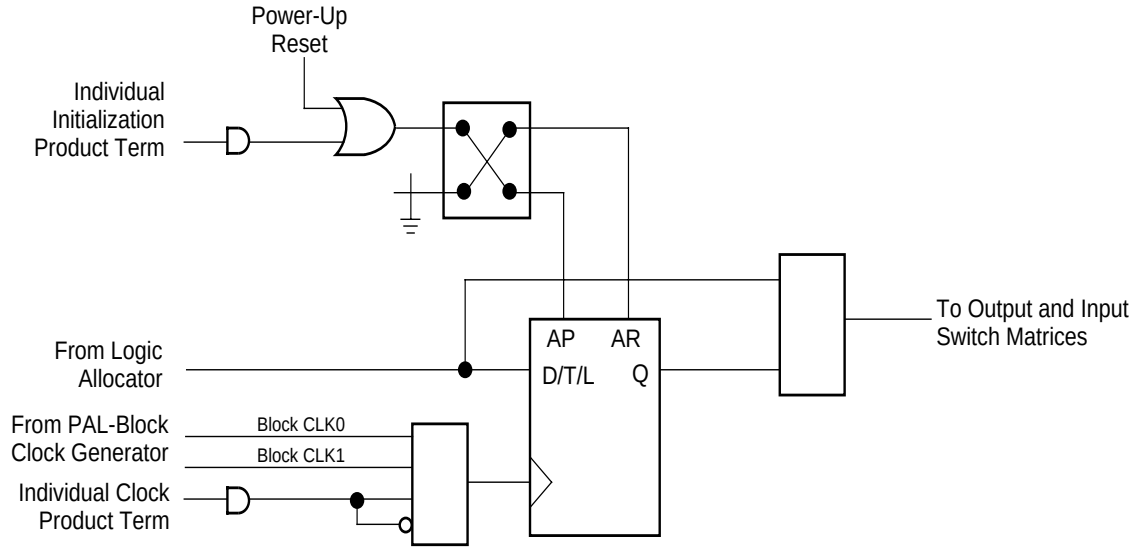
Product term clusters do not “wrap” around a PAL block. This means that the macrocells at the ends of the block have fewer product terms available.

Macrocell

The macrocell consists of a storage element, routing resources, a clock multiplexer, and initialization control. The macrocell has two fundamental modes: synchronous and asynchronous (Figure 5). The mode chosen only affects clocking and initialization in the macrocell.



a. Synchronous mode

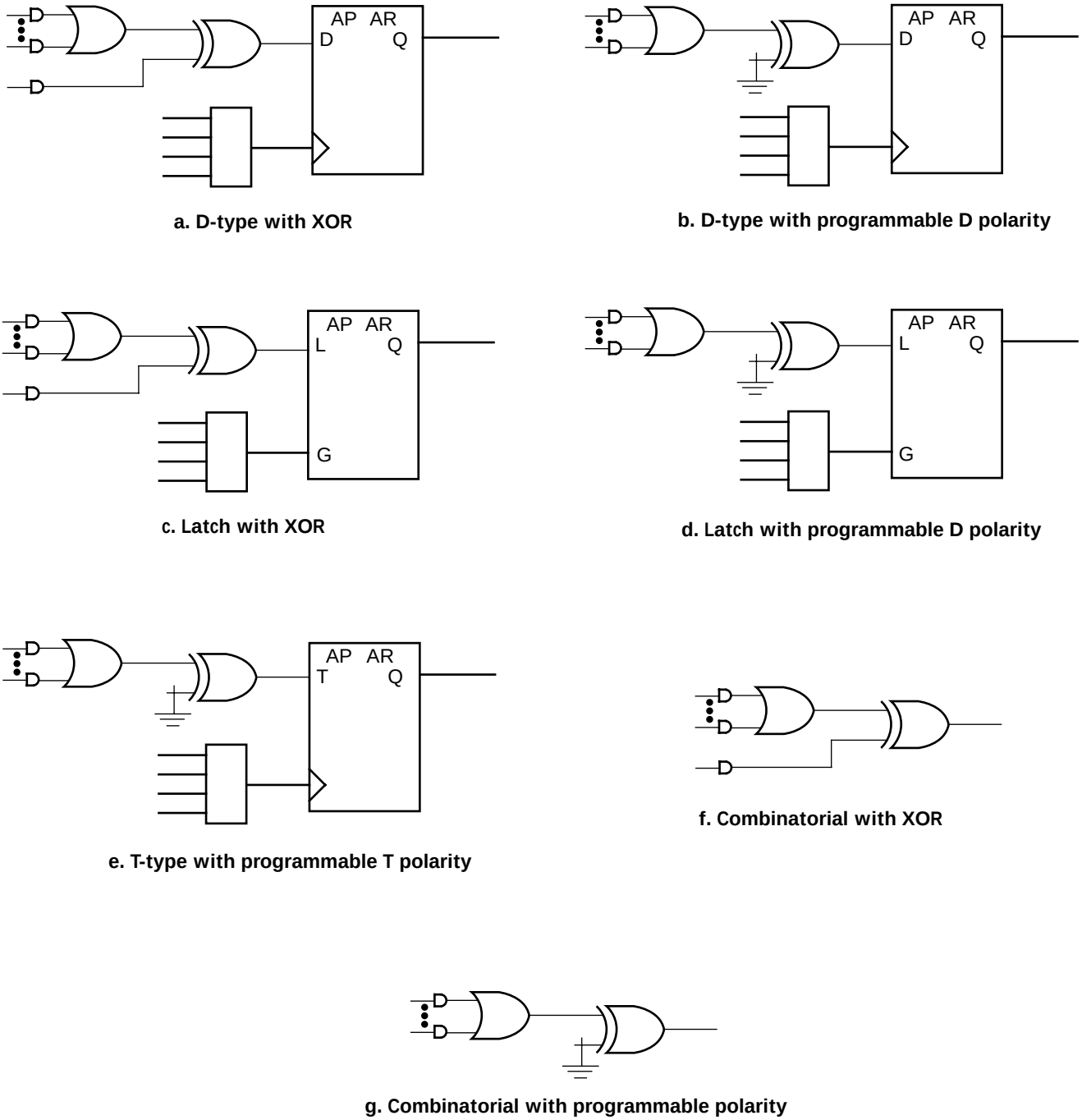


b. Asynchronous mode

Figure 5. Macrocell

In either mode, a combinatorial path can be used. For combinatorial logic, the synchronous mode will generally be used, since it provides more product terms in the allocator.

The flip-flop can be configured as a D-type or T-type latch. J-K or S-R registers can be synthesized. The primary flip-flop configurations are shown in Figure 6, although others are possible. Flip-flop functionality is defined in Table 12. Note that a J-K latch is inadvisable as it will cause oscillation if both J and K inputs are HIGH.



a. D-type with XOR

b. D-type with programmable D polarity

c. Latch with XOR

d. Latch with programmable D polarity

e. T-type with programmable T polarity

f. Combinatorial with XOR

g. Combinatorial with programmable polarity

17466G-011

Figure 6. Primary Macrocell Configurations

Table 12. Register/Latch Operation

Configuration	Input(s)	CLK/LE [1]	Q+
D-type Register	D=X	0, 1, ↓ (↑)	Q
	D=0	↑ (↓)	0
	D=1	↑ (↓)	1
T-type Register	T=X	0, 1, ↓ (↑)	Q
	T=0	↑ (↓)	Q
	T=1	↑ (↓)	$\overline{Q}$
D-type Latch	D=X	1(0)	Q
	D=0	0(1)	0
	D=1	0(1)	1

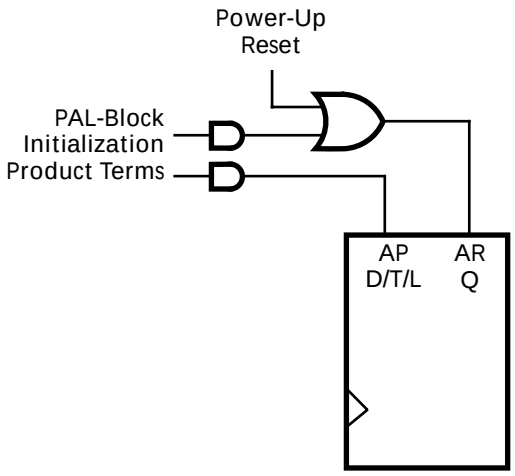
Note:

1. Polarity of CLK/LE can be programmed

Although the macrocell shows only one input to the register, the XOR gate in the logic allocator allows the D-, T-type register to emulate J-K, and S-R behavior. In this case, the available product terms are divided between J and K (or S and R). When configured as J-K, S-R, or T-type, the extra product term must be used on the XOR gate input for flip-flop emulation. In any register type, the polarity of the inputs can be programmed.

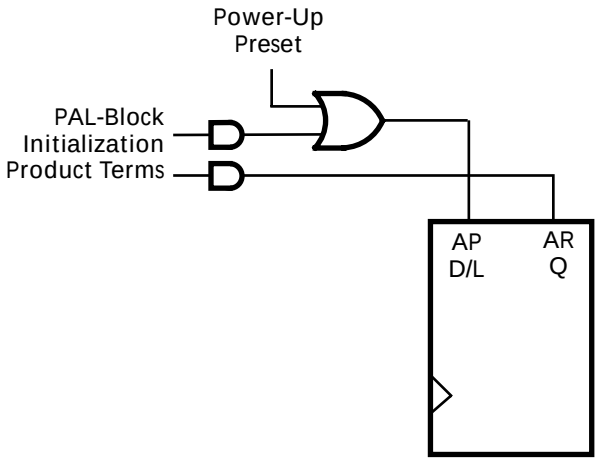
The clock input to the flip-flop can select any of the four PAL block clocks in synchronous mode, with the additional choice of either polarity of an individual product term clock in the asynchronous mode.

The initialization circuit depends on the mode. In synchronous mode (Figure 7), asynchronous reset and preset are provided, each driven by a product term common to the entire PAL block.



a. Power-up reset

17466G-012

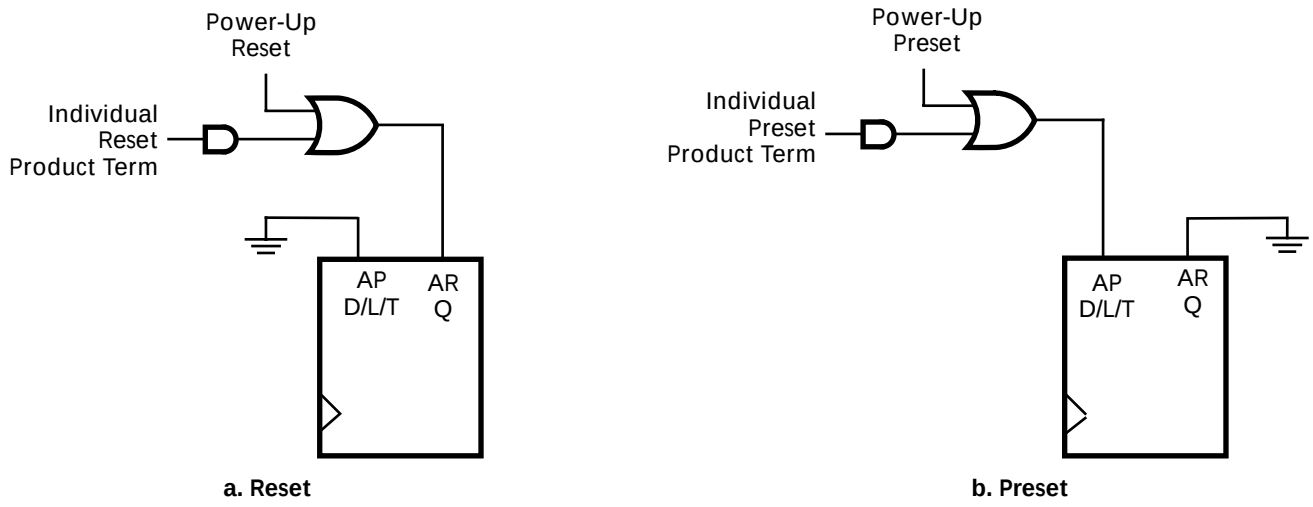


b. Power-up preset

17466G-013

Figure 7. Synchronous Mode Initialization Configurations

A reset/preset swapping feature in each macrocell allows for reset and preset to be exchanged, providing flexibility. In asynchronous mode (Figure 8), a single individual product term is provided for initialization. It can be selected to control reset or preset.



17466G-014 17466G-015

Figure 8. Asynchronous Mode Initialization Configurations

Note that the reset/preset swapping selection feature effects power-up reset as well. The initialization functionality of the flip-flops is illustrated in Table 13. The macrocell sends its data to the output switch matrix and the input switch matrix. The output switch matrix can route this data to an output if so desired. The input switch matrix can send the signal back to the central switch matrix as feedback.

Table 13. Asynchronous Reset/Preset Operation

AR	AP	CLK/LE[1]	Q+
0	0	X	See Table 12
0	1	X	1
1	0	X	0
1	1	X	0

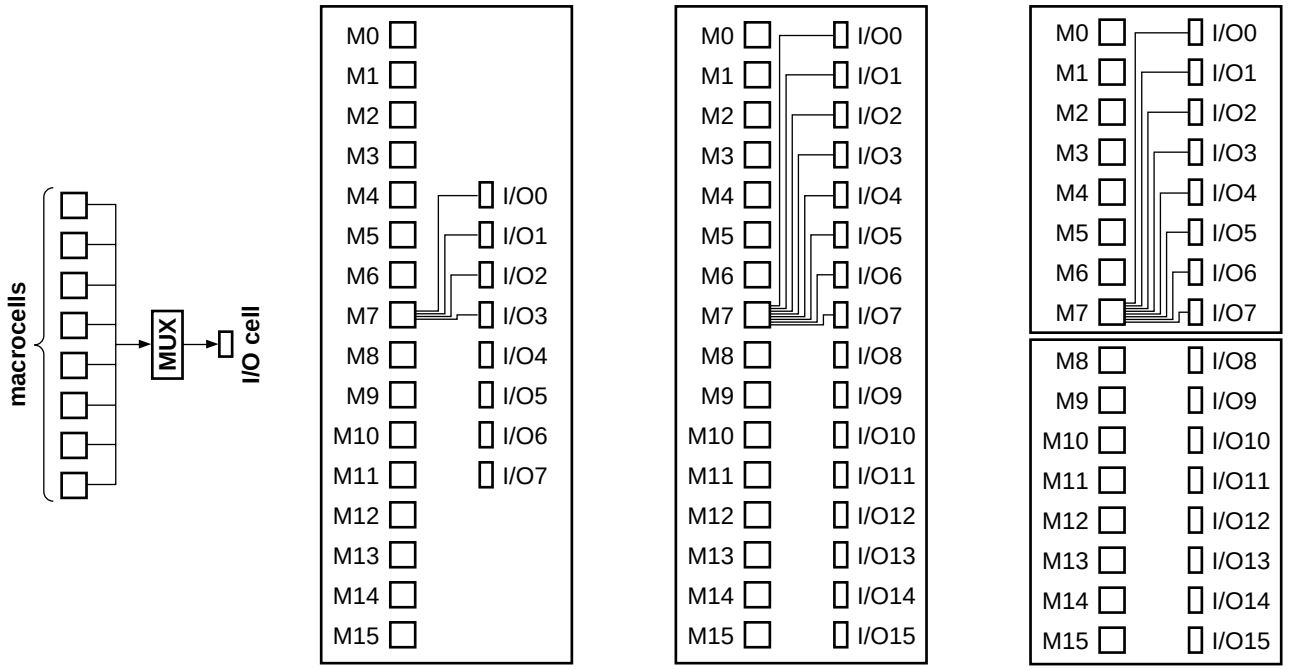
Note:

1. Transparent latch is unaffected by AR, AP

Output Switch Matrix

The output switch matrix allows macrocells to be connected to any of several I/O cells within a PAL block. This provides high flexibility in determining pinout and allows design changes to occur without effecting pinout.

In MACH 4 and MACH 4A devices with 2:1 Macrocell-I/O cell ratio, each PAL block has twice as many macrocells as I/O cells. The MACH 4 output switch matrix allows for half of the macrocells to drive I/O cells within a PAL block, in combinations according to Figure 9. Each I/O cell can choose from eight macrocells; each macrocell has a choice of four I/O cells. The MACH 4 and MACH 4A devices with 1:1 Macrocell-I/O cell ratio allow each macrocell to drive one of eight I/O cells (Figure 9).



Each I/O cell can choose one of 8 macrocells in all MACH 4 and MACH 4A devices.

Each macrocell can drive one of 4 I/O cells in MACH 4 and MACH 4A devices with 2:1 macrocell-I/O cell ratio.

Each macrocell can drive one of 8 I/O cells in MACH 4A devices with 1:1 macrocell-I/O cell ratio except M4A(3, 5)-32/32 devices.

Each macrocell can drive one of 8 I/O cells in M4(LV)-32/32 and M4A(3, 5)-32/32 devices.

Figure 9. MACH 4 Output Switch Matrix

Table 14. Output Switch Matrix Combinations for MACH 4 and MACH 4A Devices with 2:1 Macrocell-I/O Cell Ratio

Macrocell	Routable to I/O Cells
M0, M1	I/O0, I/O5, I/O6, I/O7
M2, M3	I/O0, I/O1, I/O6, I/O7
M4, M5	I/O0, I/O1, I/O2, I/O7
M6, M7	I/O0, I/O1, I/O2, I/O3
M8, M9	I/O1, I/O2, I/O3, I/O4
M10, M11	I/O2, I/O3, I/O4, I/O5
M12, M13	I/O3, I/O4, I/O5, I/O6
M14, M15	I/O4, I/O5, I/O6, I/O7

I/O Cell	Available Macrocells
I/O0	M0, M1, M2, M3, M4, M5, M6, M7
I/O1	M2, M3, M4, M5, M6, M7, M8, M9
I/O2	M4, M5, M6, M7, M8, M9, M10, M11
I/O3	M6, M7, M8, M9, M10, M11, M12, M13
I/O4	M8, M9, M10, M11, M12, M13, M14, M15
I/O5	M0, M1, M10, M11, M12, M13, M14, M15

Table 14. Output Switch Matrix Combinations for MACH 4 and MACH 4A Devices with 2:1 Macrocell-I/O Cell Ratio

Macrocell	Routable to I/O Cells
I/O6	M0, M1, M2, M3, M12, M13, M14, M15
I/O7	M0, M1, M2, M3, M4, M5, M14, M15

Table 15. Output Switch Matrix Combinations for MACH 4 and MACH 4A Devices with 1:1 Macrocell-I/O Cell Ratio except M4(LV)-32/32 and M4A(3,5)-32/32

Macrocell	Routable to I/O Cells							
M0	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M1	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M2	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M3	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M4	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M5	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M6	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M7	I/O0	I/O1	I/O2	I/O3	I/O4	I/O5	I/O6	I/O7
M8	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M9	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M10	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M11	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M12	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M13	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M14	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15
M15	I/O8	I/O9	I/O10	I/O11	I/O12	I/O13	I/O14	I/O15

I/O Cell	Available Macrocells							
I/O0	M0	M1	M2	M3	M4	M5	M6	M7
I/O1	M0	M1	M2	M3	M4	M5	M6	M7
I/O2	M0	M1	M2	M3	M4	M5	M6	M7
I/O3	M0	M1	M2	M3	M4	M5	M6	M7
I/O4	M0	M1	M2	M3	M4	M5	M6	M7
I/O5	M0	M1	M2	M3	M4	M5	M6	M7
I/O6	M0	M1	M2	M3	M4	M5	M6	M7
I/O7	M0	M1	M2	M3	M4	M5	M6	M7
I/O8	M8	M9	M10	M11	M12	M13	M14	M15
I/O9	M8	M9	M10	M11	M12	M13	M14	M15
I/O10	M8	M9	M10	M11	M12	M13	M14	M15
I/O11	M8	M9	M10	M11	M12	M13	M14	M15
I/O12	M8	M9	M10	M11	M12	M13	M14	M15
I/O13	M8	M9	M10	M11	M12	M13	M14	M15
I/O14	M8	M9	M10	M11	M12	M13	M14	M15
I/O15	M8	M9	M10	M11	M12	M13	M14	M15

Table 16. Output Switch Matrix Combinations for M4(LV)-32/32 and M4A(3,5)-32/32

Macrocell	Routable to I/O Cells
M0, M1, M2, M3, M4, M5, M6, M7	I/O0, I/O1, I/O2, I/O3, I/O4, I/O5, I/O6, I/O7
M8, M9, M10, M11, M12, M13, M14, M15	I/O8, I/O9, I/O10, I/O11, I/O12, I/O13, I/O14, I/O15

I/O Cell	Available Macrocells
I/O0, I/O1, I/O2, I/O3, I/O4, I/O5, I/O6, I/O7	M0, M1, M2, M3, M4, M5, M6, M7
I/O8, I/O9, I/O10, I/O11, I/O12, I/O13, I/O14, I/O15	M8, M9, M10, M11, M12, M13, M14, M15

I/O Cell

The I/O cell (Figures 10 and 11) simply consists of a programmable output enable, a feedback path, and flip-flop (except MACH 4 and MACH 4A devices with 1:1 macrocell-I/O cell ratio.) An individual output enable product term is provided for each I/O cell. The feedback signal drives the input switch matrix.

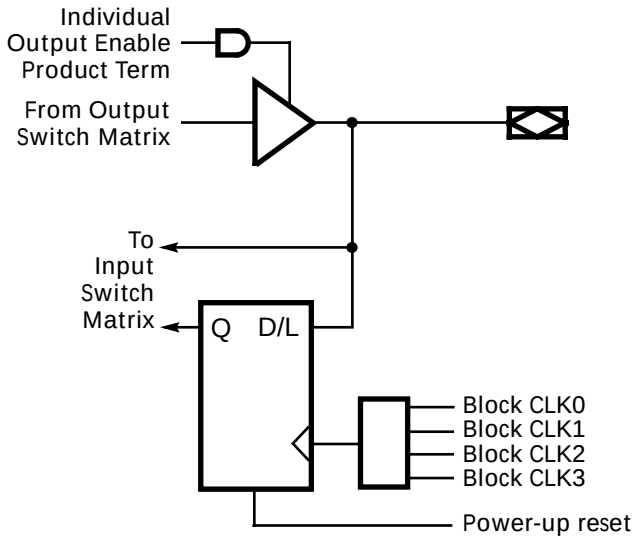


Figure 10. I/O Cell for MACH 4 and MACH 4A Devices with 2:1 Macrocell-I/O Cell Ratio

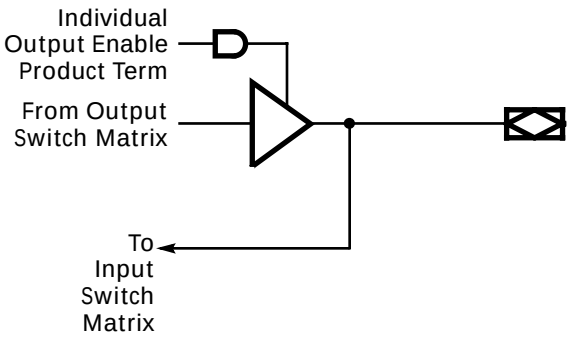


Figure 11. I/O Cell for MACH 4 and MACH 4A Devices with 1:1 Macrocell-I/O Cell Ratio

The I/O cell (Figure 10) contains a flip-flop, which provides the capability for storing the input in a D-type register or latch. The clock can be any of the PAL block clocks. Both the direct and registered versions of the input are sent to the input switch matrix. This allows for such functions as "time-domain-multiplexed" data comparison, where the first data value is stored, and then the second data value is put on the I/O pin and compared with the previous stored value.

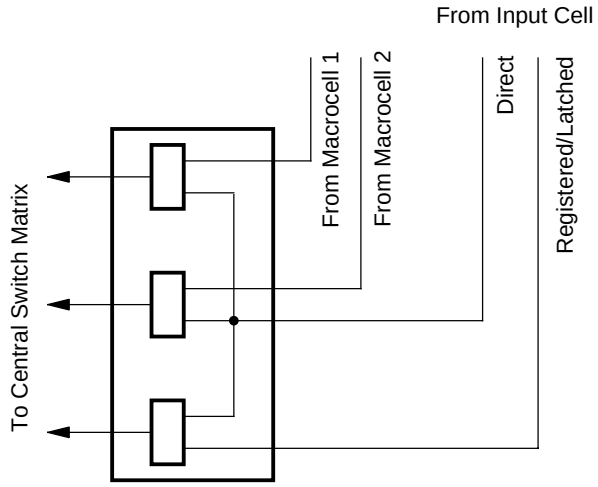
Note that the flip-flop used in the MACH 4 I/O cell is independent of the flip-flops in the macrocells. It powers up to a logic low.

Zero-Hold-Time Input Register

The MACH 4 devices have a zero-hold-time (ZHT) fuse which controls the time delay associated with loading data into all I/O cell registers and latches. When programmed, the ZHT fuse increases the data path setup delays to input storage elements, matching equivalent delays in the clock path. When the fuse is erased, the setup time to the input storage element is minimized. This feature facilitates doing worst-case designs for which data is loaded from sources which have low (or zero) minimum output propagation delays from clock edges.

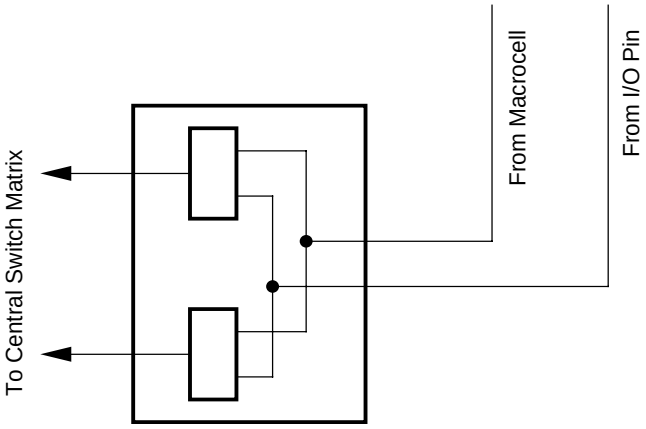
Input Switch Matrix

The input switch matrix (Figures 12 and 13) optimizes routing of inputs to the central switch matrix. Without the input switch matrix, each input and feedback signal has only one way to enter the central switch matrix. The input switch matrix provides additional ways for these signals to enter the central switch matrix.



17466G-002

Figure 12. MACH 4 and MACH 4A with 2:1 Macrocell-I/O Cell Ratio - Input Switch Matrix

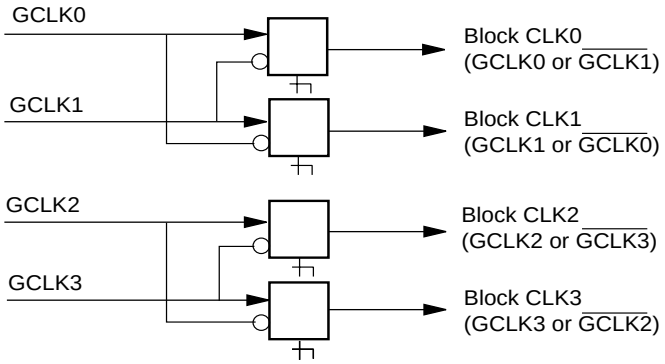


17466G-003

Figure 13. MACH 4 and MACH 4A with 1:1 Macrocell-I/O Cell Ratio - Input Switch Matrix

PAL Block Clock Generation

Each MACH 4 device has four clock pins that can also be used as inputs. These pins drive a clock generator in each PAL block (Figure 14). The clock generator provides four clock signals that can be used anywhere in the PAL block. These four PAL block clock signals can consist of a large number of combinations of the true and complement edges of the global clock signals. Table 17 lists the possible combinations.



17466G-004

Figure 14. PAL Block Clock Generator [1]

Note:

1. *M4(LV)-32/32, M4A(3,5)-32/32, M4(LV)-64/32 and M4A(3,5)-64/32 have only two clock pins, GCLK0 and GCLK1. GCLK2 is tied to GCLK0, and GCLK3 is tied to GCLK1.*

Table 17. PAL Block Clock Combinations[1]

Block CLK0	Block CLK1	Block CLK2	Block CLK3
GCLK0	GCLK1	X	X
$\overline{\text{GCLK1}}$	GCLK1	X	X
GCLK0	$\overline{\text{GCLK0}}$	X	X
$\overline{\text{GCLK1}}$	$\overline{\text{GCLK0}}$	X	X
X	X	GCLK2 (GCLK0)	GCLK3 (GCLK1)
X	X	$\overline{\text{GCLK3}}$ ($\overline{\text{GCLK1}}$)	GCLK3 (GCLK1)
X	X	GCLK2 (GCLK0)	$\overline{\text{GCLK2}}$ ($\overline{\text{GCLK0}}$)
X	X	$\overline{\text{GCLK3}}$ ($\overline{\text{GCLK1}}$)	$\overline{\text{GCLK2}}$ ($\overline{\text{GCLK0}}$)

Note:

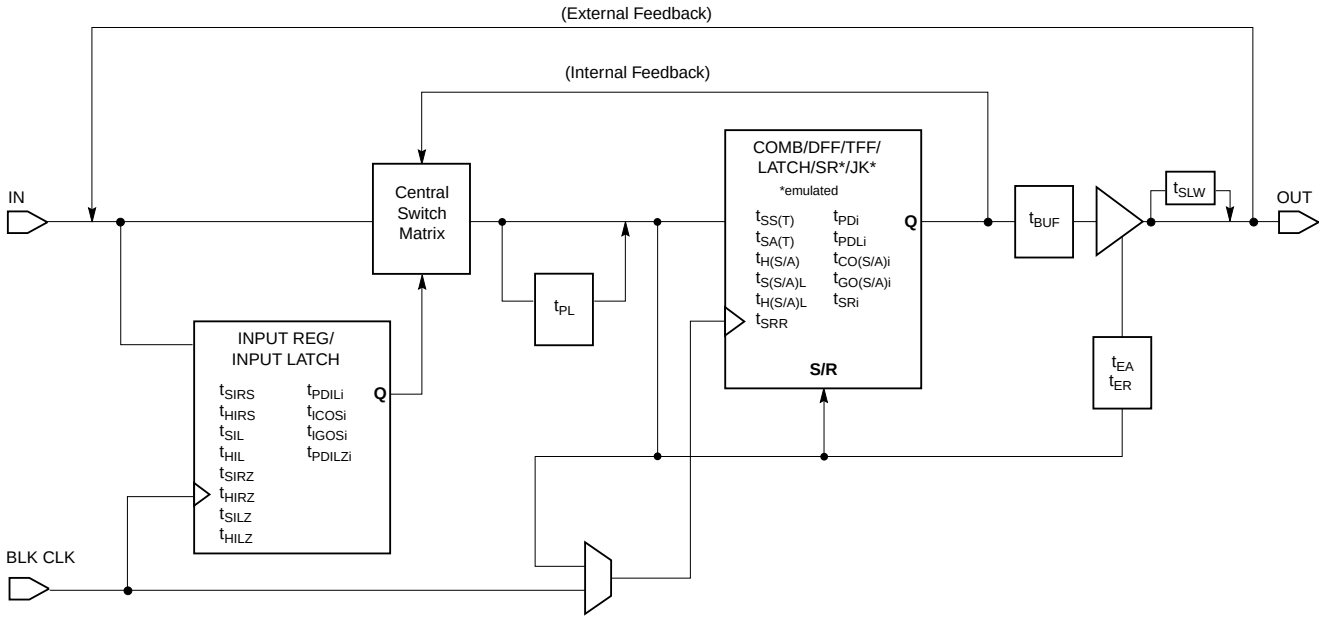
1. Values in parentheses are for the M4(LV)-32/32, M4A(3,5)-32/32, M4(LV)-64/32 and M4A(3,5)-64/32.

This feature provides high flexibility for partitioning state machines and dual-phase clocks. It also allows latches to be driven with either polarity of latch enable, and in a master-slave configuration.

MACH 4 TIMING MODEL

The primary focus of the MACH 4 timing model is to accurately represent the timing in a MACH 4 device, and at the same time, be easy to understand. This model accurately describes all combinatorial and registered paths through the device, making a distinction between **internal feedback** and **external feedback**. A signal uses internal feedback when it is fed back into the switch matrix or block without having to go through the output buffer. The input register specifications are also reported as internal feedback. When a signal is fed back into the switch matrix after having gone through the output buffer, it is using external feedback.

The parameter, t_{BUF}, is defined as the time it takes to go from feedback through the output buffer to the I/O pad. If a signal goes to the internal feedback rather than to the I/O pad, the parameter designator is followed by an "i". By adding t_{BUF} to this internal parameter, the external parameter is derived. For example, $t_{PD} = t_{PDi} + t_{BUF}$. A diagram representing the modularized MACH 4 timing model is shown in Figure 15. Refer to the Technical Note entitled *MACH 4 Timing and High Speed Design* for a more detailed discussion about the timing parameters.



17466G-025

Figure 15. MACH 4 Timing Model

SPEEDLOCKING FOR GUARANTEED FIXED TIMING

The MACH 4 architecture allows allocation of up to 20 product terms to an individual macrocell with the assistance of an XOR gate without incurring additional timing delays.

The design of the switch matrix and PAL blocks guarantee a fixed pin-to-pin delay that is independent of the logic required by the design. Other competitive CPLDs incur serious timing delays as product terms expand beyond their typical 4 or 5 product term limits. Speed *and* SpeedLocking combine to give designs easy access to the performance required in today's designs.

IEEE 1149.1-COMPLIANT BOUNDARY SCAN TESTABILITY

All MACH 4 devices, except the M4(LV)-128N/64, have boundary scan cells and are compliant to the IEEE 1149.1 standard. This allows functional testing of the circuit board on which the device is mounted through a serial scan path that can access all critical logic nodes. Internal registers are linked internally, allowing test data to be shifted in and loaded directly onto test nodes, or test node data to be captured and shifted out for verification. In addition, these devices can be linked into a board-level serial scan path for more complete board-level testing.

IEEE 1149.1-COMPLIANT IN-SYSTEM PROGRAMMING

Programming devices in-system provides a number of significant benefits including: rapid prototyping, lower inventory levels, higher quality, and the ability to make in-field modifications. All MACH 4 devices provide In-System Programming (ISP) capability through their Boundary ScanTest Access Ports. This capability has been implemented in a manner that ensures that the port remains compliant to the IEEE 1149.1 standard. By using IEEE 1149.1 as the communication interface through which ISP is achieved, customers get the benefit of a standard, well-defined interface.

MACH 4 devices can be programmed across the commercial temperature and voltage range. The PC-based Lattice/VantisPRO software facilitates in-system programming of MACH 4 devices. Lattice/VantisPRO takes the JEDEC file output produced by the design implementation software, along with information about the JTAG chain, and creates a set of vectors that are used to drive the JTAG chain. Lattice/VantisPRO software can use these vectors to drive a JTAG chain via the parallel port of a PC. Alternatively, Lattice/VantisPRO software can output files in formats understood by common automated test equipment. This equpment can then be used to program MACH 4 devices during the testing of a circuit board.

PCI COMPLIANT

MACH 4(A) devices in the -5/-55/-65/-7/-10/-12 speed grades are compliant with the *PCI Local Bus Specification* version 2.1, published by the PCI Special Interest Group (SIG). The 5-V devices are fully PCI-compliant. The 3.3-V devices are mostly compliant but do not meet the PCI condition to clamp the inputs as they rise above V_{CC} because of their 5-V input tolerant feature.

SAFE FOR MIXED SUPPLY VOLTAGE SYSTEM DESIGNS

Both the 3.3-V and 5-V V_{CC} MACH 4 devices are safe for mixed supply voltage system designs. The 5-V devices will not overdrive 3.3-V devices above the output voltage of 3.3 V, while they accept inputs from other 3.3-V devices. The 3.3-V device will accept inputs up to 5.5 V. Both the 5-V and 3.3-V versions have the same high-speed performance and provide easy-to-use mixed-voltage design capability.

PULL UP OR BUS-FRIENDLY INPUTS AND I/OS

All MACH 4 devices have inputs and I/Os which feature the Bus-Friendly circuitry incorporating two inverters in series which loop back to the input. This double inversion weakly holds the input at its last driven logic state. While it is good design practice to tie unused pins to a known state, the Bus-Friendly input structure pulls pins away from the input threshold voltage where noise can cause high-frequency switching. At power-up, the Bus-Friendly latches are reset to a logic level “1.” For the circuit diagram, please refer to the *Input/Output Equivalent Schematics (page 393)* in the General Information Section of the Vantis 1999 Data Book.

All MACH 4A devices have a programmable bit that configures all inputs and I/Os with either pull-up or Bus-Friendly characteristics. If the device is configured in pull-up mode, all inputs and I/O pins are weakly pulled up. For the circuit diagram, please refer to the *Input/Output Equivalent Schematics (page 393)* in the General Information Section of the Vantis 1999 Data Book.

POWER MANAGEMENT

Each individual PAL block in MACH 4 devices features a programmable low-power mode, which results in power savings of up to 50%. The signal speed paths in the low-power PAL block will be slower than those in the non-low-power PAL block. This feature allows speed critical paths to run at maximum frequency while the rest of the signal paths operate in the low-power mode.

PROGRAMMABLE SLEW RATE

Each MACH 4 device I/O has an individually programmable output slew rate control bit. Each output can be individually configured for the higher speed transition (3 V/ns) or for the lower noise transition (1 V/ns). For high-speed designs with long, unterminated traces, the slow-slew rate will introduce fewer reflections, less noise, and keep ground bounce to a minimum. For designs with short traces or well terminated lines, the fast slew rate can be used to achieve the highest speed. The slew rate is adjusted independent of power.

POWER-UP RESET/SET

All flip-flops power up to a known state for predictable system initialization. If a macrocell is configured to SET on a signal from the control generator, then that macrocell will be SET during device power-up. If a macrocell is configured to RESET on a signal from the control generator or is not configured for set/reset, then that macrocell will RESET on power-up. To guarantee initialization values, the V_{CC} rise must be monotonic, and the clock must be inactive until the reset delay time has elapsed.

SECURITY BIT

A programmable security bit is provided on the MACH 4 devices as a deterrent to unauthorized copying of the array configuration patterns. Once programmed, this bit defeats readback of the programmed pattern by a device programmer, securing proprietary designs from competitors. Programming and verification are also defeated by the security bit. The bit can only be reset by erasing the entire device.

HOT SOCKETING

MACH 4A devices are well-suited for those applications that require hot socketing capability. Hot socketing a device requires that the device, when powered down, can tolerate active signals on the I/Os and inputs without being damaged. Additionally, it requires that the effects of the powered-down MACH devices be minimal on active signals.

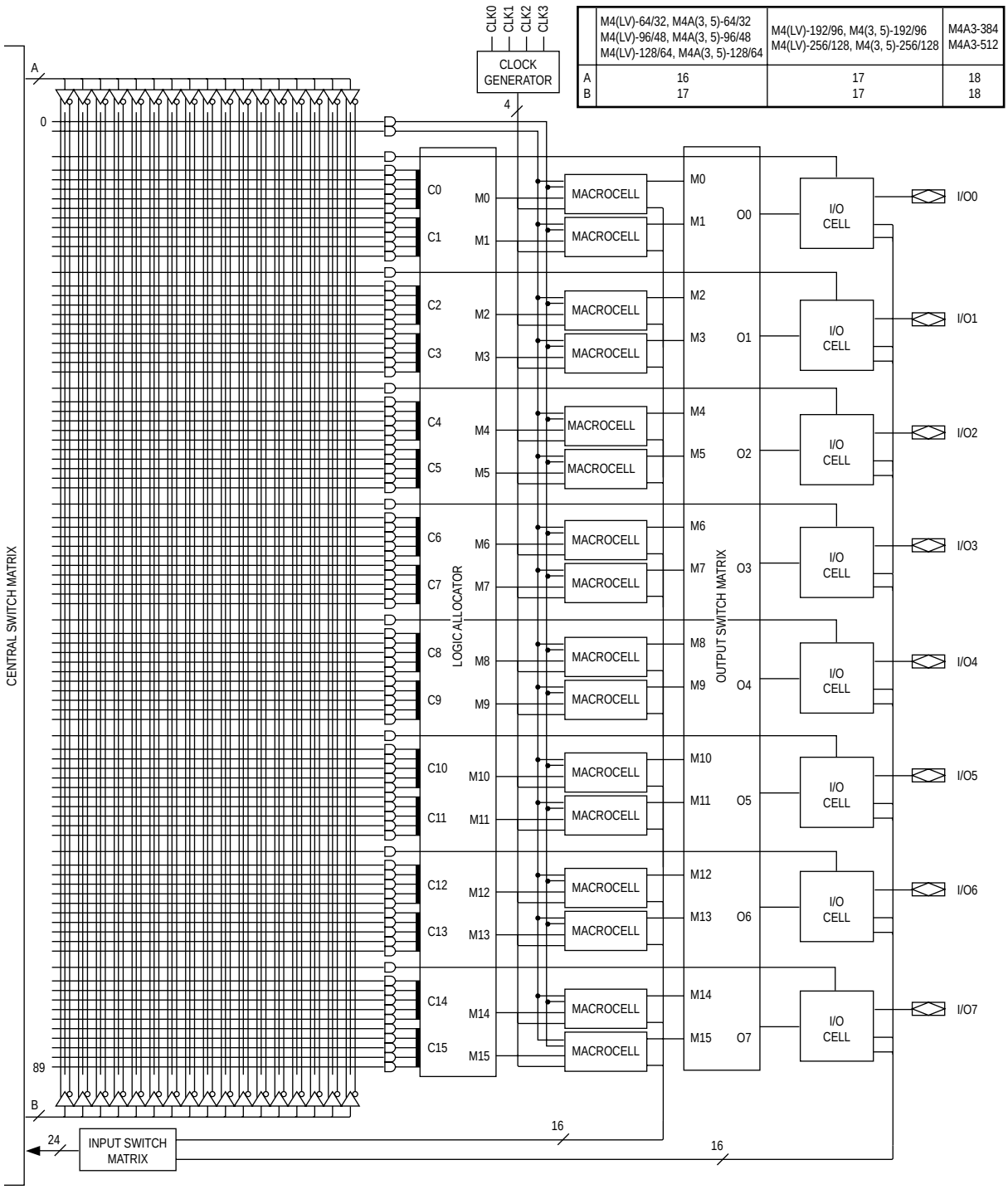


Figure 16. PAL Block for MACH 4 and MACH 4A with 2:1 Macrocell - I/O Cell Ratio

17466H-40

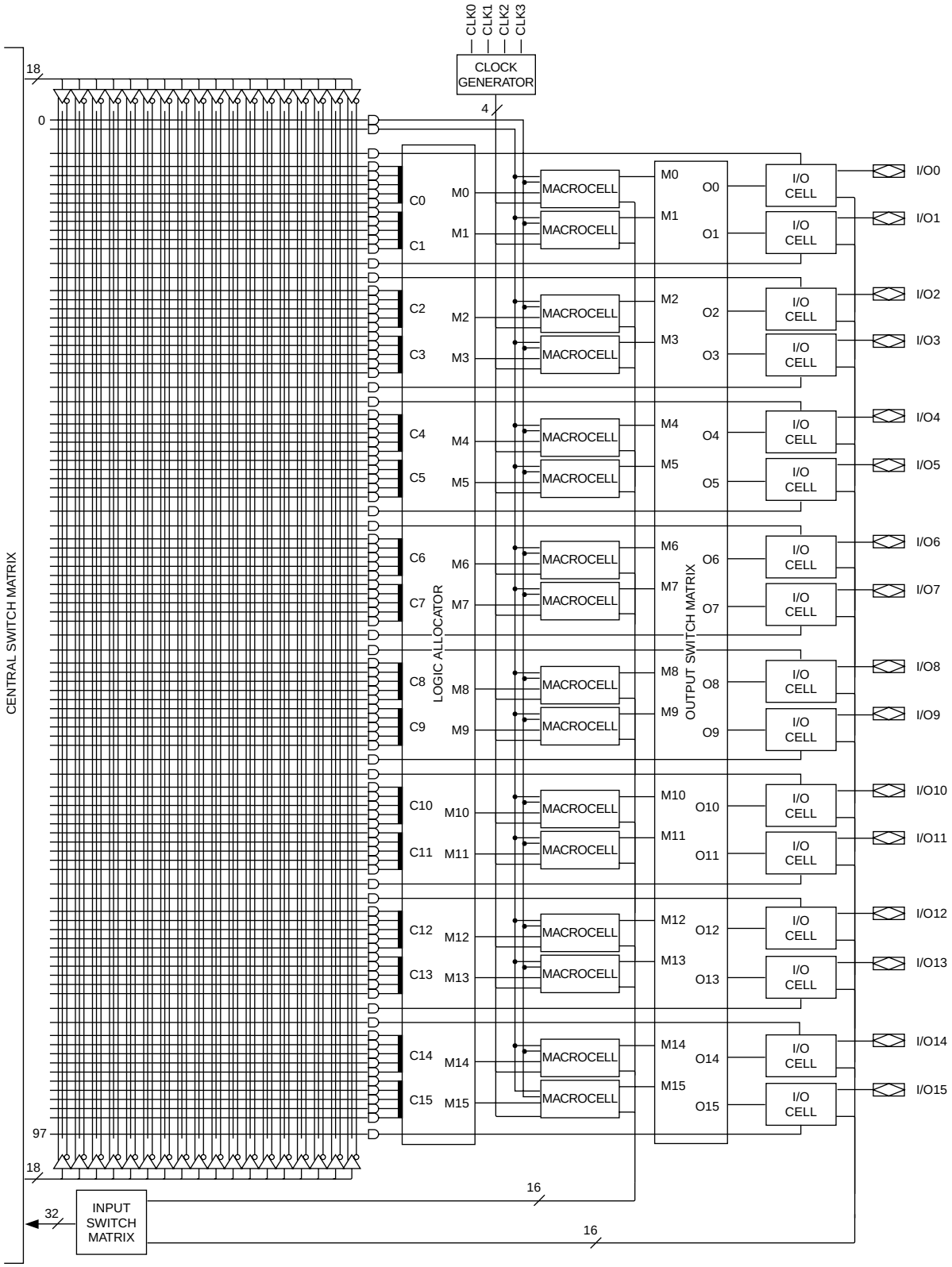


Figure 17. PAL Block for MACH 4A Devices with 1:1 Macrocell-I/O Cell Ratio (except M4A (3,5)-32/32)

17466H-41

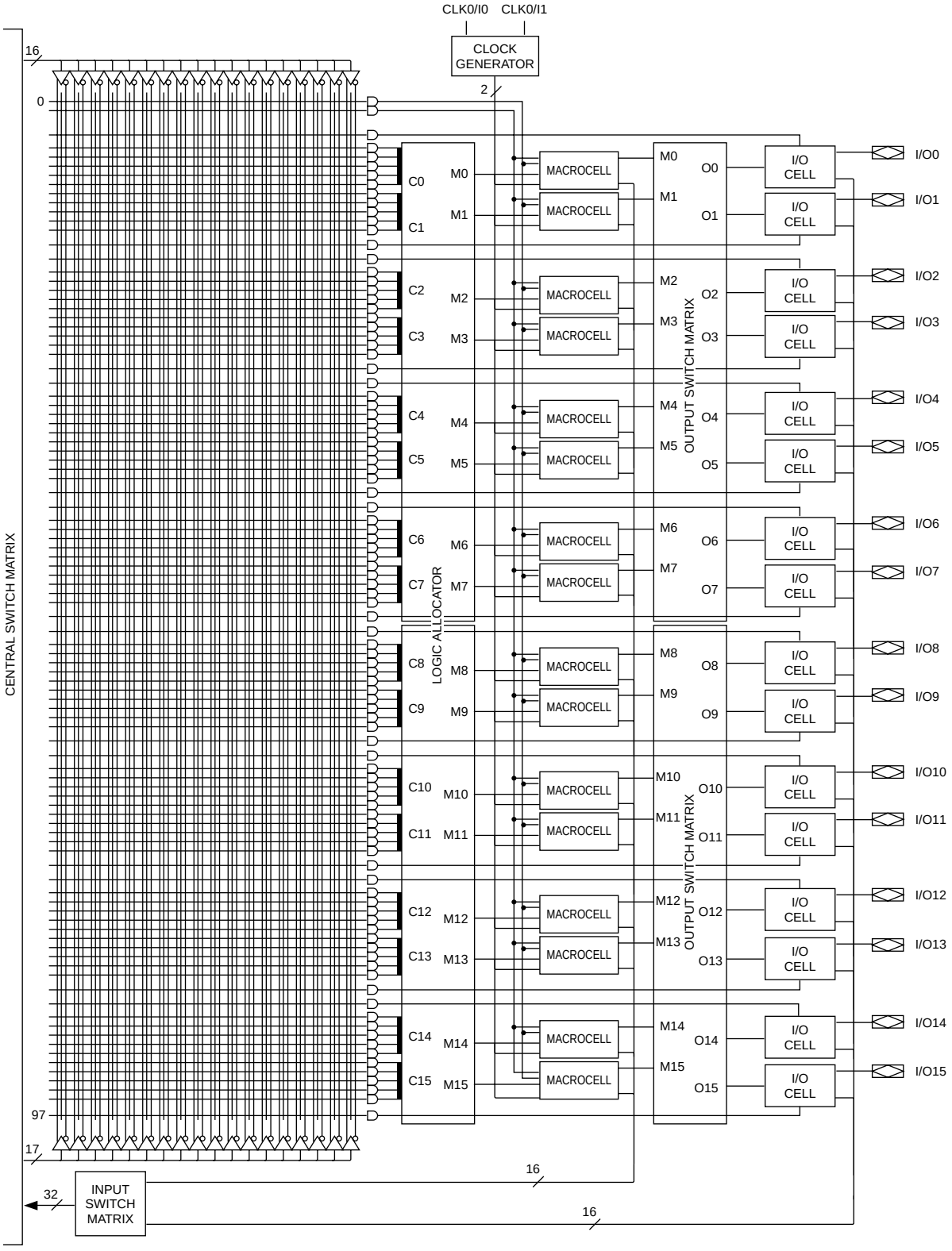
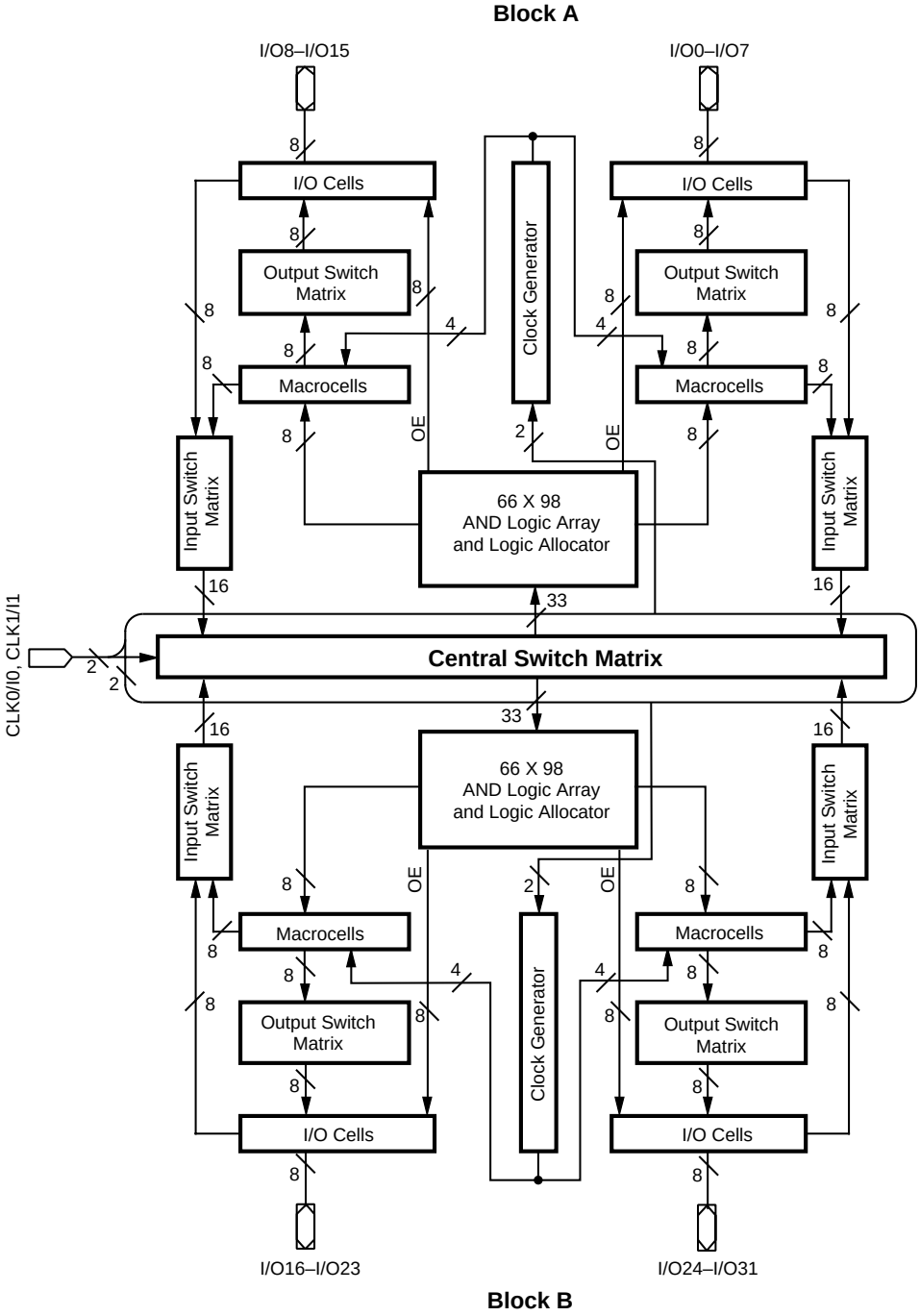


Figure 18. PAL Block for M4(LV)-32/32 and M4A (3,5)-32/32

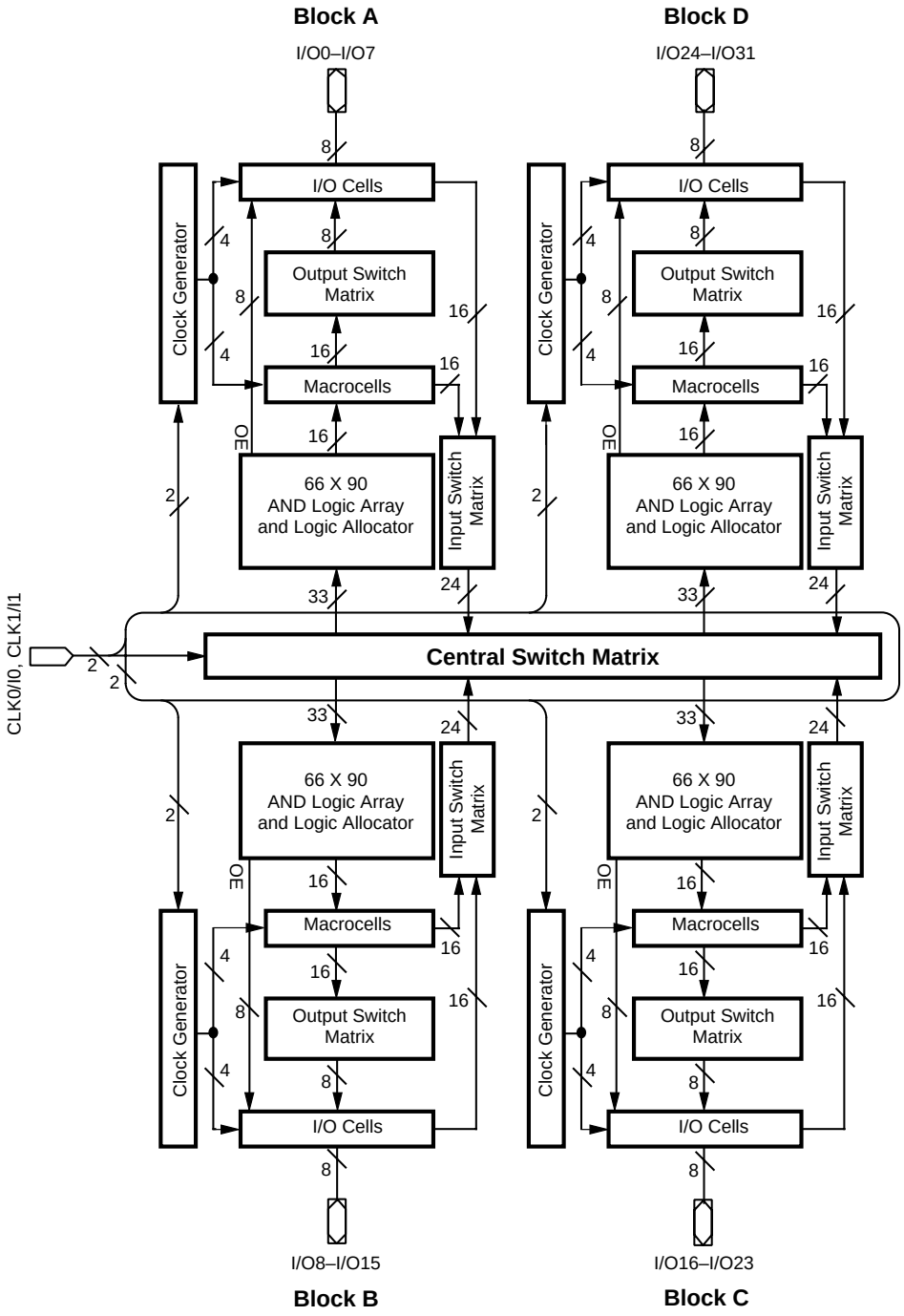
17466H-042

BLOCK DIAGRAM – M4(LV)-32/32 AND M4A(3,5)-32/32



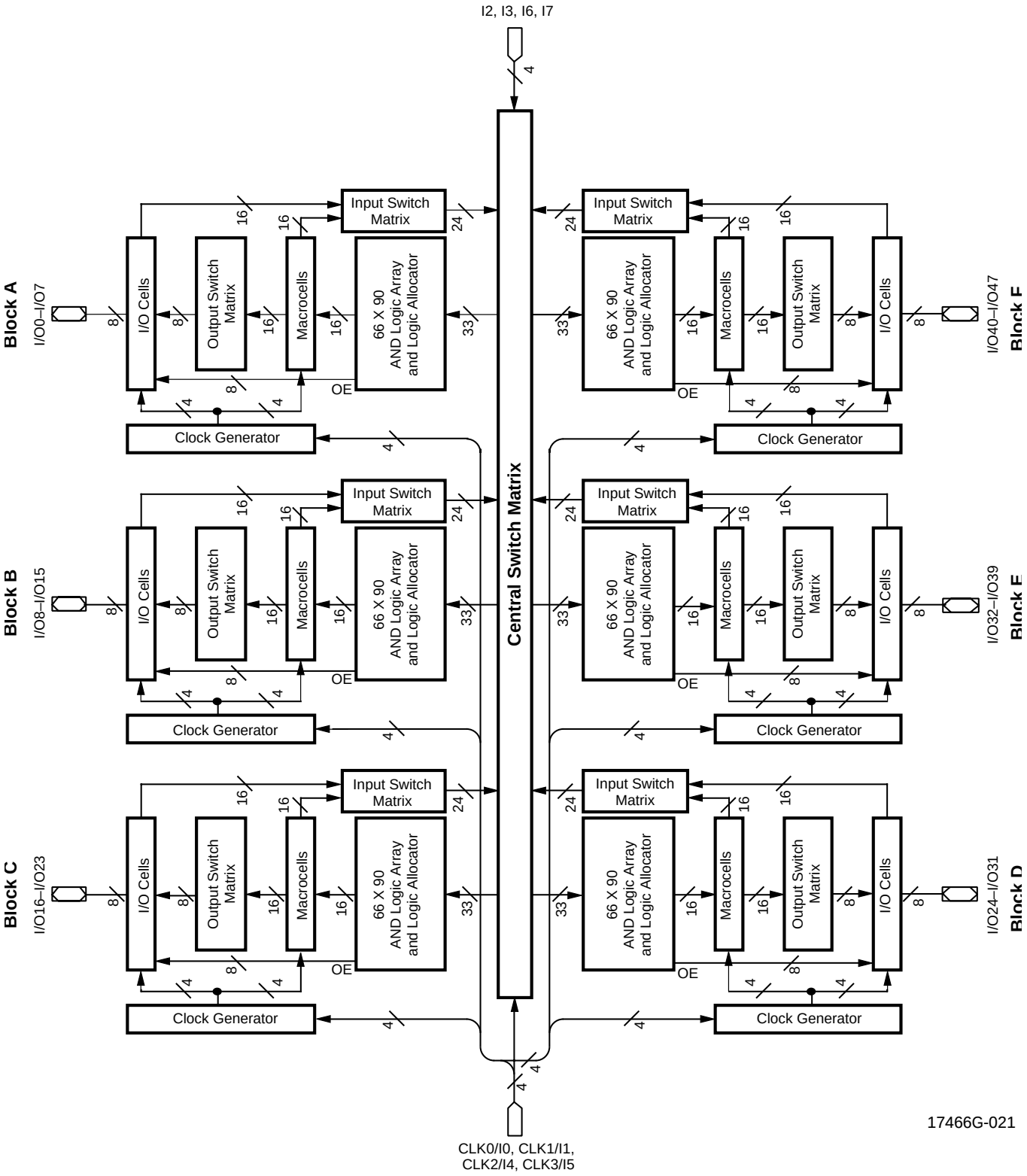
17466H-019

BLOCK DIAGRAM – M4(LV)-64/32 AND M4A(3,5)-64/32

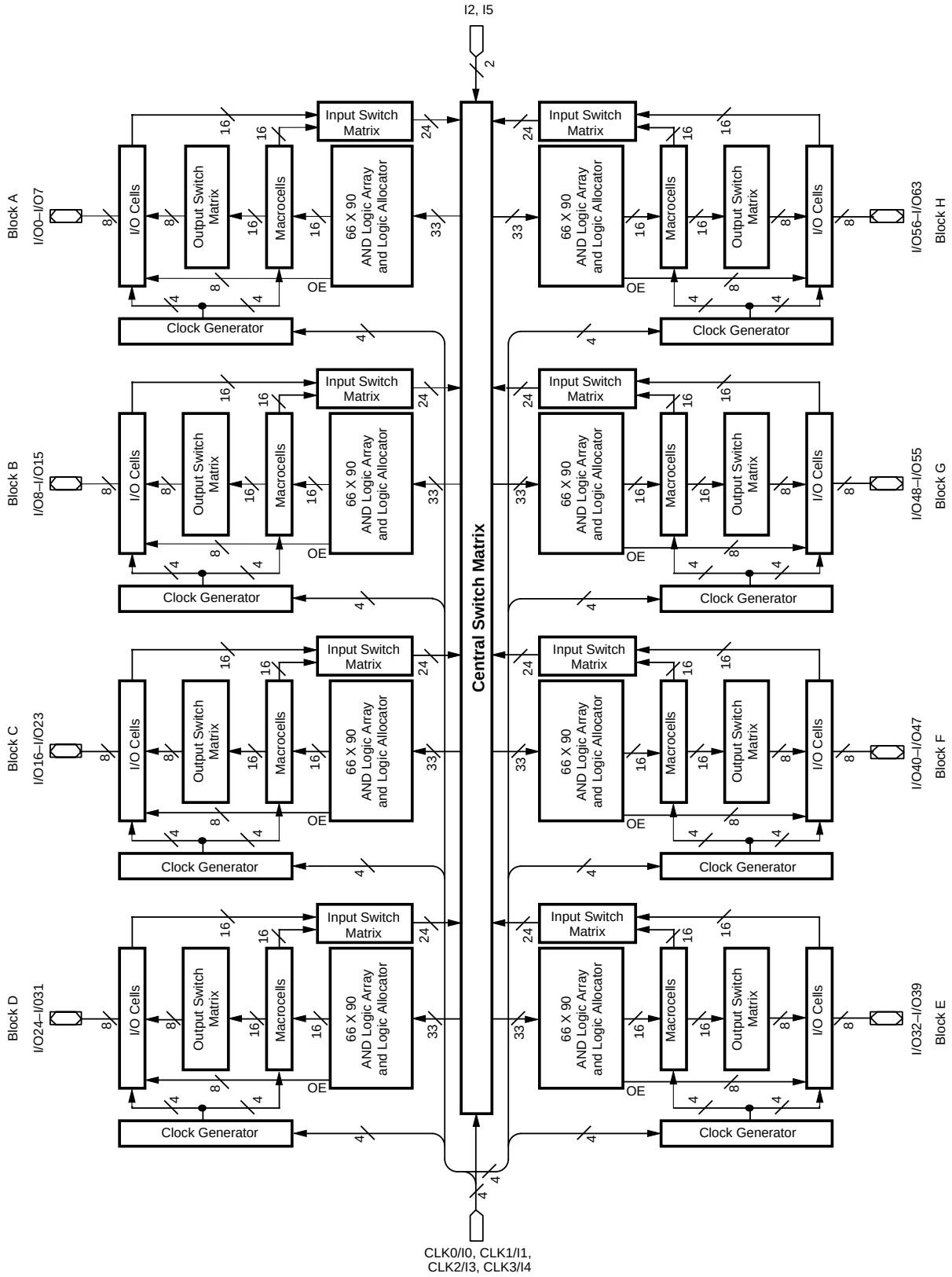


17466H-020

BLOCK DIAGRAM – M4(LV)-96/48 AND M4A(3,5)-96/48

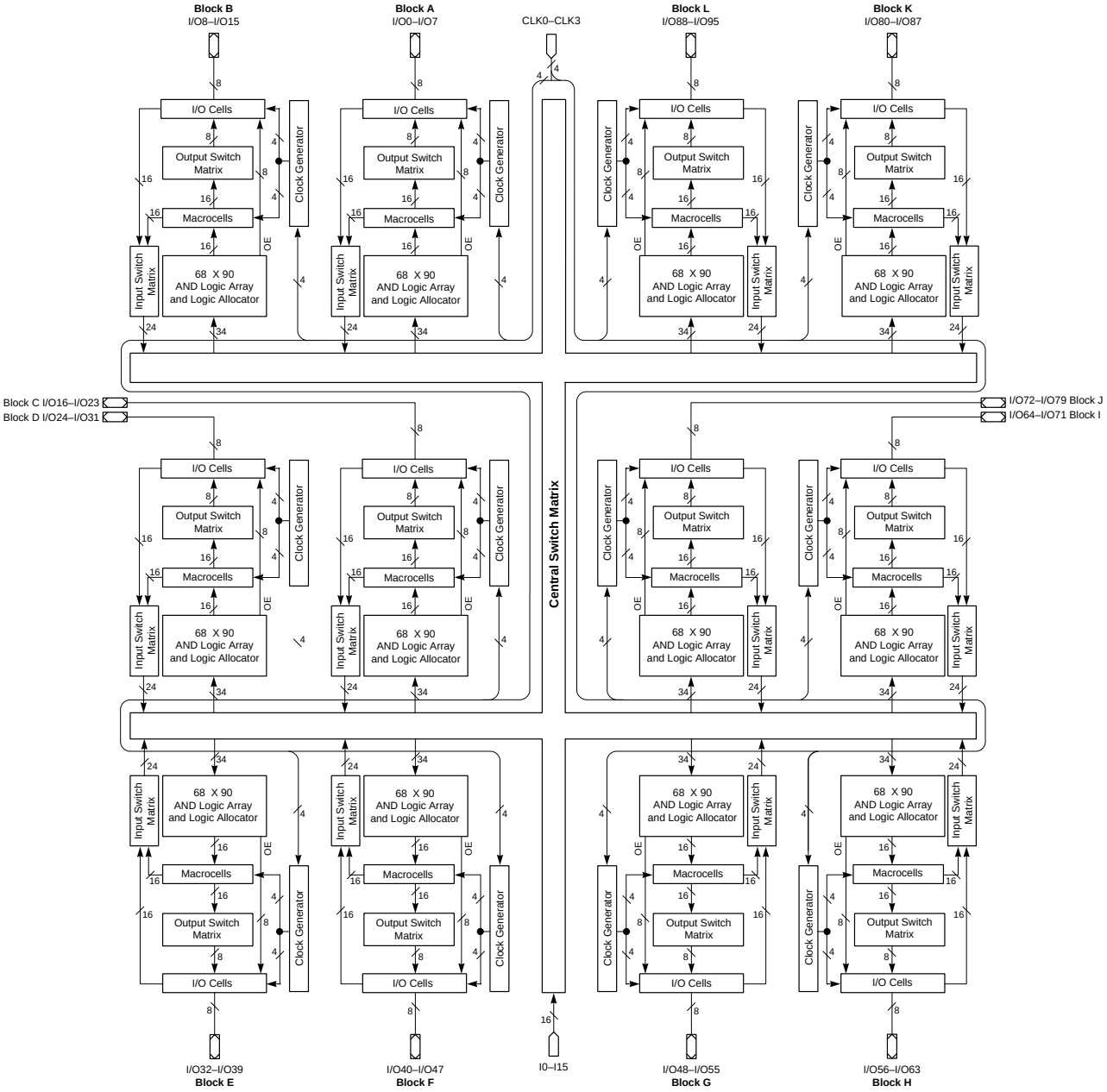


BLOCK DIAGRAM – M4(LV)-128N/64, M4(LV)-128/64 AND M4A(3,5)-128/64



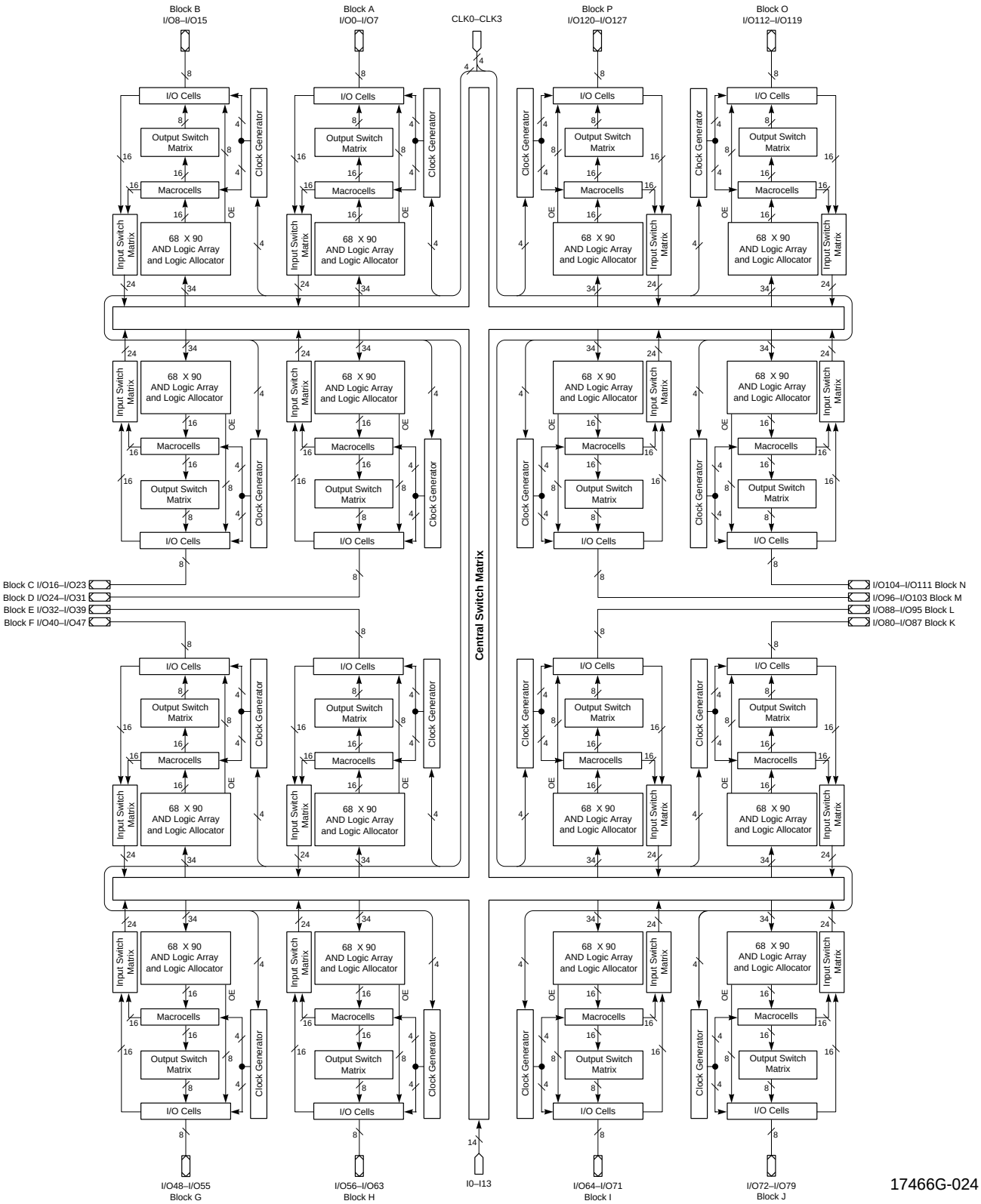
17466H-022

BLOCK DIAGRAM – M4(LV)-192/96 AND M4A(3,5)-192/96

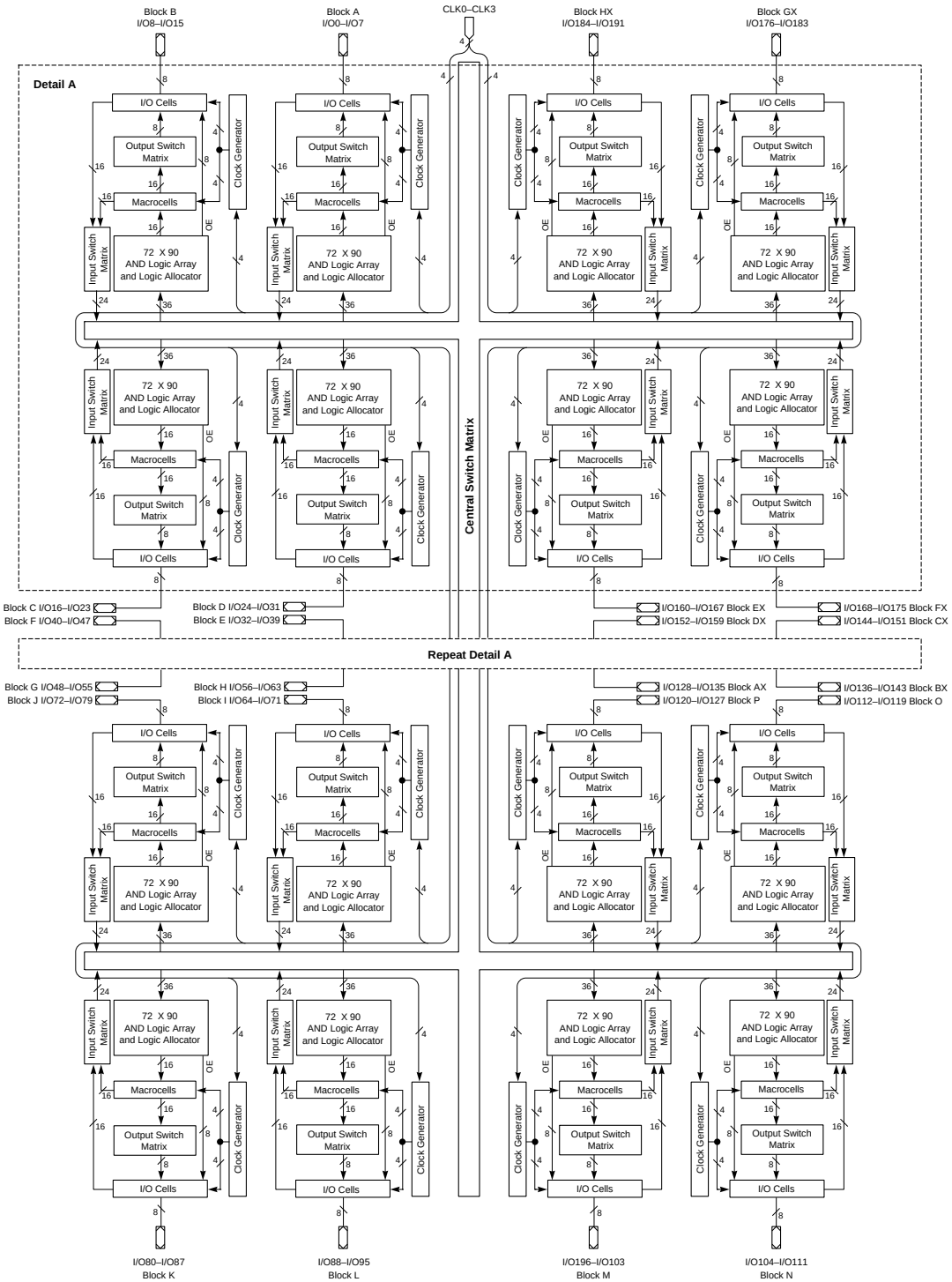


17466G-064

BLOCK DIAGRAM – M4(LV)-256/128 AND M4A(3,5)-256/128

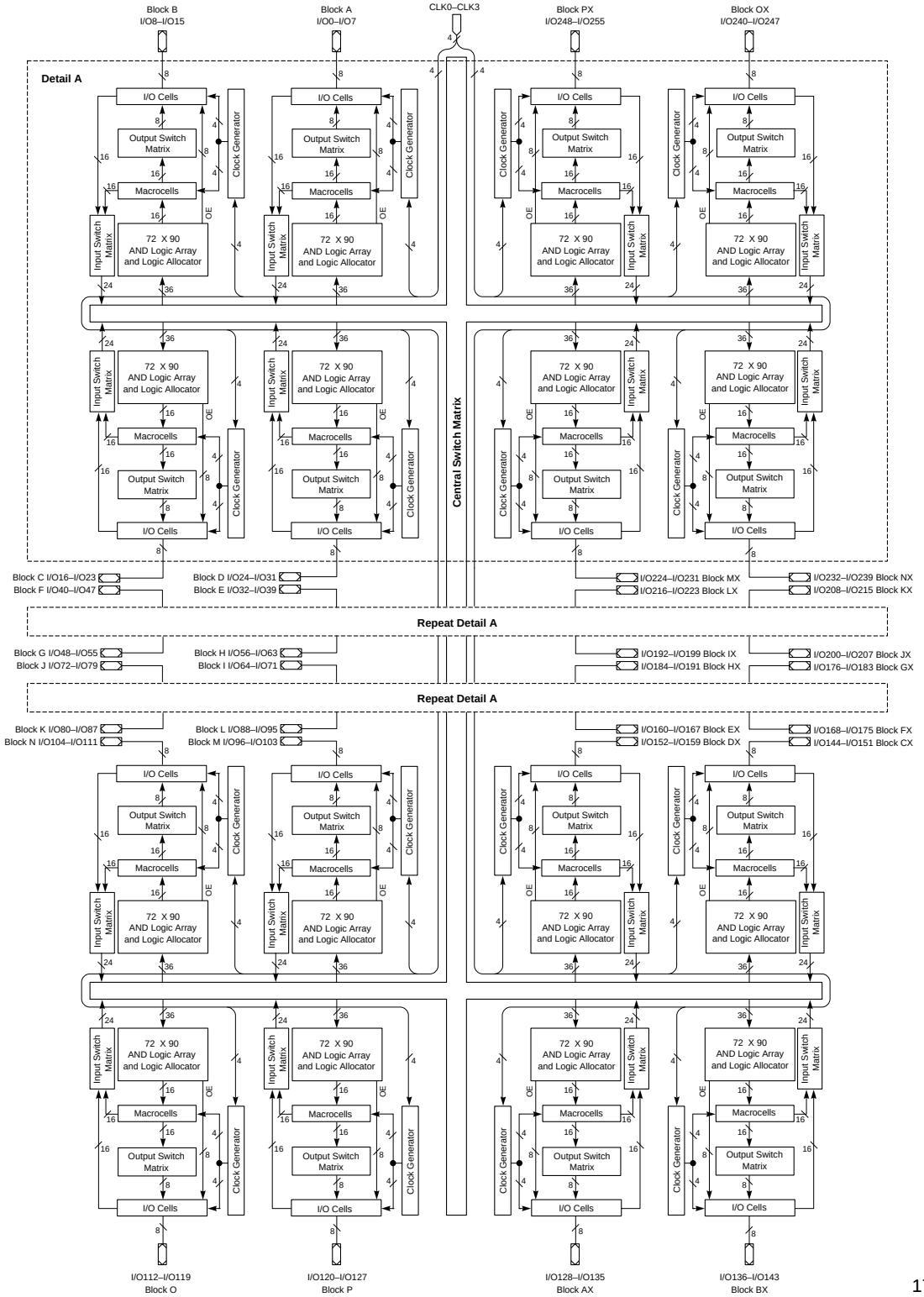


BLOCK DIAGRAM – M4A3-384/192



17466G-067

BLOCK DIAGRAM - M4A3-512/256



17466G-068

ABSOLUTE MAXIMUM RATINGS

M4 and M4A5

Storage Temperature . . . . . -65°C to +150°C

Ambient Temperature
with Power Applied . . . . . -55°C to +100°C

Device Junction Temperature . . . . . +130°C

Supply Voltage
with Respect to Ground . . . . . -0.5 V to +7.0 V

DC Input Voltage . . . . . -0.5 V to V_{CC} + 0.5 V

Static Discharge Voltage . . . . . 2000 V

Latchup Current (T_A = -40°C to +85°C). . . . . 200 mA

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A)
Operating in Free Air. . . . . 0°C to +70°C

Supply Voltage (V_{CC})
with Respect to Ground . . . . . +4.75 V to +5.25 V

Industrial (I) Devices

Ambient Temperature (T_A)
Operating in Free Air. . . . . -40°C to +85°C

Supply Voltage (V_{CC})
with Respect to Ground . . . . . +4.50 V to +5.5 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

5-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Conditions	Min	Typ	Max	Unit
V_{OH}	Output HIGH Voltage	I_{OH} = –3.2 mA, V_{CC} = Min, V_{IN} = V_{IH} or V_{IL}	2.4			V
		I_{OH} = 0 mA, V_{CC} = Max, V_{IN} = V_{IH} or V_{IL}			3.3	V
V_{OL}	Output LOW Voltage	I_{OL} = 24 mA, V_{CC} = Min, V_{IN} = V_{IH} or V_{IL} (Note 1)			0.5	V
V_{IH}	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for all Inputs (Note 2)	2.0			V
V_{IL}	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for all Inputs (Note 2)			0.8	V
I_{IH}	Input HIGH Leakage Current	V_{IN} = 5.25 V, V_{CC} = Max (Note 3)			10	µA
I_{IL}	Input LOW Leakage Current	V_{IN} = 0 V, V_{CC} = Max (Note 3)			–10	µA
I_{OZH}	Off-State Output Leakage Current HIGH	V_{OUT} = 5.25 V, V_{CC} = Max, V_{IN} = V_{IH} or V_{IL} (Note 3)			10	µA
I_{OZL}	Off-State Output Leakage Current LOW	V_{OUT} = 0 V, V_{CC} = Max , V_{IN} = V_{IH} or V_{IL} (Note 3)			–10	µA
I_{SC}	Output Short-Circuit Current	V_{OUT} = 0.5 V, V_{CC} = Max (Note 4)	–30		–160	mA

Notes:

1. *Total I_{OL} for one PAL block should not exceed 64 mA.*
2. *These are absolute values with respect to device ground, and all overshoots due to system or tester noise are included.*
3. *I/O pin leakage is the worst case of I_{IL} and I_{OZL} (or I_{IH} and I_{OZH}).*
4. *Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second. V_{OUT} = 0.5 V has been chosen to avoid test problems caused by tester ground degradation.*

ABSOLUTE MAXIMUM RATINGS

M4LV and M4A3

Storage Temperature . . . . . -65°C to +150°C

Ambient Temperature
with Power Applied . . . . . -55°C to +100°C

Device Junction Temperature . . . . . +130°C

Supply Voltage
with Respect to Ground . . . . . -0.5 V to +4.5 V

DC Input Voltage . . . . . -0.5 V to 6.0 V

Static Discharge Voltage . . . . . 2000 V

Latchup Current (T_A = -40°C to +85°C). . . . . 200 mA

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to Absolute Maximum Ratings for extended periods may affect device reliability.

OPERATING RANGES

Commercial (C) Devices

Ambient Temperature (T_A)
Operating in Free Air . . . . . 0°C to +70°C

Supply Voltage (V_{CC})
with Respect to Ground . . . . . +3.0 V to +3.6 V

Industrial (I) Devices

Ambient Temperature (T_A)
Operating in Free Air . . . . . -40°C to +85°C

Supply Voltage (V_{CC})
with Respect to Ground . . . . . +3.0 V to +3.6 V

Operating ranges define those limits between which the functionality of the device is guaranteed.

3.3-V DC CHARACTERISTICS OVER OPERATING RANGES

Parameter Symbol	Parameter Description	Test Conditions		Min	Typ	Max	Unit
V_{OH}	Output HIGH Voltage	V_{CC} = Min, V_{IN} = V_{IH} or V_{IL}	I_{OH} = –100 µA	V_{CC} – 0.2			V
			I_{OH} = –3.2 mA	2.4			V
V_{OL}	Output LOW Voltage	V_{CC} = Min, V_{IN} = V_{IH} or V_{IL} (Note 1)	I_{OL} = 100 µA			0.2	V
			I_{OL} = 24 mA			0.5	V
V_{IH}	Input HIGH Voltage	Guaranteed Input Logical HIGH Voltage for all Inputs		2.0		5.5	V
V_{IL}	Input LOW Voltage	Guaranteed Input Logical LOW Voltage for all Inputs		–0.3		0.8	V
I_{IH}	Input HIGH Leakage Current	V_{IN} = 3.6 V, V_{CC} = Max (Note 2)				5	µA
I_{IL}	Input LOW Leakage Current	V_{IN} = 0 V, V_{CC} = Max (Note 2)				–5	µA
I_{OZH}	Off-State Output Leakage Current HIGH	V_{OUT} = 3.6 V, V_{CC} = Max, V_{IN} = V_{IH} or V_{IL} (Note 2)				5	µA
I_{OZL}	Off-State Output Leakage Current LOW	V_{OUT} = 0 V, V_{CC} = Max, V_{IN} = V_{IH} or V_{IL} (Note 2)				–5	µA
I_{SC}	Output Short-Circuit Current	V_{OUT} = 0.5 V, V_{CC} = Max (Note 3)		–15		–160	mA

Notes:

1. *Total I_{OL} for one PAL block should not exceed 64 mA.*
2. *I/O pin leakage is the worst case of I_{IL} and I_{OZL} (or I_{IH} and I_{OZH}).*
3. *Not more than one output should be shorted at a time and duration of the short-circuit should not exceed one second.*

MACH 4 TIMING PARAMETERS OVER OPERATING RANGES[1]

		-7		-10		-12		-14		-15		-18		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Combinatorial Delay:														
t_{PDi}	Internal combinatorial propagation delay		5.5		8.0		10.0		12.0		13.0		16.0	ns
t_{PD}	Combinatorial propagation delay		7.5		10.0		12.0		14.0		15.0		18.0	ns
Registered Delays:														
t_{SS}	Synchronous clock setup time, D-type register	5.5		6.0		7.0		10.0		10.0		12.0		ns
t_{SST}	Synchronous clock setup time, T-type register	6.5		7.0		8.0		11.0		11.0		13.0		ns
t_{SA}	Asynchronous clock setup time, D-type register	3.5		4.0		5.0		8.0		8.0		10.0		ns
t_{SAT}	Asynchronous clock setup time, T-type register	4.5		5.0		6.0		9.0		9.0		11.0		ns
t_{HS}	Synchronous clock hold time	0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{HA}	Asynchronous clock hold time	3.5		4.0		5.0		8.0		8.0		10.0		ns
t_{COSi}	Synchronous clock to internal output		3.5		4.5		6.0		8.0		8.0		10.0	ns
t_{COS}	Synchronous clock to output		5.5		6.5		8.0		10.0		10.0		12.0	ns
t_{COAi}	Asynchronous clock to internal output		7.5		10.0		12.0		16.0		16.0		18.0	ns
t_{COA}	Asynchronous clock to output		9.5		12.0		14.0		18.0		18.0		20.0	ns
Latched Delays:														
t_{SSL}	Synchronous Latch setup time	6.0		7.0		8.0		10.0		10.0		12.0		ns
t_{SAL}	Asynchronous Latch setup time	4.0		4.0		5.0		8.0		8.0		10.0		ns
t_{HSL}	Synchronous Latch hold time	0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{HAL}	Asynchronous Latch hold time	4.0		4.0		5.0		8.0		8.0		10.0		ns
t_{PDLi}	Transparent latch to internal output		8.0		10.0		12.0		15.0		15.0		18.0	ns
t_{PDL}	Propagation delay through transparent latch to output		10.0		12.0		14.0		17.0		17.0		20.0	ns
t_{GOSi}	Synchronous Gate to internal output		4.0		5.5		8.0		9.0		9.0		10.0	ns
t_{GOS}	Synchronous Gate to output		6.0		7.5		10.0		11.0		11.0		12.0	ns
t_{GOAi}	Asynchronous Gate to internal output		9.0		11.0		14.0		17.0		17.0		20.0	ns
t_{GOA}	Asynchronous Gate to output		11.0		13.0		16.0		19.0		19.0		22.0	ns
Input Register Delays:														
t_{SIRS}	Input register setup time	2.0		2.0		2.0		2.0		2.0		2.0		ns
t_{HIRS}	Input register hold time	3.0		3.0		3.0		4.0		4.0		4.0		ns
t_{ICOSi}	Input register clock to internal feedback		3.5		4.5		6.0		6.0		6.0		6.0	ns
Input Latch Delays:														
t_{SIL}	Input latch setup time	2.0		2.0		2.0		2.0		2.0		2.0		ns
t_{HIL}	Input latch hold time	3.0		3.0		3.0		4.0		4.0		4.0		ns
t_{IGOSi}	Input latch gate to internal feedback		4.0		4.0		4.0		5.0		5.0		6.0	ns
t_{PDILi}	Transparent input latch to internal feedback		2.0		2.0		2.0		2.0		2.0		2.0	ns
Input Register Delays with ZHT Option:														
t_{SIRZ}	Input register setup time - ZHT	6.0		6.0		6.0		6.0		6.0		6.0		ns
t_{HIRZ}	Input register hold time - ZHT	0.0		0.0		0.0		0.0		0.0		0.0		ns

MACH 4 TIMING PARAMETERS OVER OPERATING RANGES[1] (CONTINUED)

		-7		-10		-12		-14		-15		-18		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Input Latch Delays with ZHT Option:														
t_{SILZ}	Input latch setup time - ZHT	6.0		6.0		6.0		6.0		6.0		6.0		ns
t_{HILZ}	Input latch hold time - ZHT	0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{PDILZi}	Transparent input latch to internal feedback - ZHT		6.0		6.0		6.0		6.0		6.0		6.0	ns
Output Delays:														
t_{BUF}	Output buffer delay		2.0		2.0		2.0		2.0		2.0		2.0	ns
t_{SLW}	Slow slew rate delay adder		2.5		2.5		2.5		2.5		2.5		2.5	ns
t_{EA}	Output enable time		9.5		10.0		12.0		15.0		15.0		17.0	ns
t_{ER}	Output disable time		9.5		10.0		12.0		15.0		15.0		17.0	ns
Power Delay:														
t_{PL}	Power-down mode delay adder		2.5		2.5		2.5		2.5		2.5		2.5	ns
Reset and Preset Delays:														
t_{SRi}	Asynchronous reset or preset to internal register output		10.0		12.0		14.0		18.0		18.0		20.0	ns
t_{SR}	Asynchronous reset or preset to register output		12.0		14.0		16.0		20.0		20.0		22.0	ns
t_{SRR}	Asynchronous reset and preset register recovery time	8.0		8.0		10.0		15.0		15.0		17.0		ns
t_{SRW}	Asynchronous reset or preset width	10.0		10.0		12.0		15.0		15.0		17.0		ns
Clock/LE Width:														
t_{WLS}	Global clock width low	3.0		5.0		6.0		6.0		6.0		7.0		ns
t_{WHS}	Global clock width high	3.0		5.0		6.0		6.0		6.0		7.0		ns
t_{WLA}	Product term clock width low	4.0		5.0		8.0		9.0		9.0		10.0		ns
t_{WHA}	Product term clock width high	4.0		5.0		8.0		9.0		9.0		10.0		ns
t_{GWS}	Global gate width low (for low transparent) or high (for high transparent)	5.0		5.0		6.0		6.0		6.0		7.0		ns
t_{GWA}	Product term gate width low (for low transparent) or high (for high transparent)	4.0		5.0		6.0		9.0		9.0		11.0		ns
t_{WIRL}	Input register clock width low	4.5		5.0		6.0		6.0		6.0		7.0		ns
t_{WIRH}	Input register clock width high	4.5		5.0		6.0		6.0		6.0		7.0		ns
t_{WIL}	Input latch gate width	5.0		5.0		6.0		6.0		6.0		7.0		ns

MACH 4 TIMING PARAMETERS OVER OPERATING RANGES[1] (CONTINUED)

		-7		-10		-12		-14		-15		-18		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Frequency:														
f_{MAXS}	External feedback, D-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SS} + t_{COS})$	90.9		80.0		66.7		50.0		50.0		41.7		MHz
	External feedback, T-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SST} + t_{COS})$	83.3		74.1		62.5		47.6		47.6		40.0		MHz
	Internal feedback (f_{CNT}), D-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SS} + t_{COSi})$	111.1		95.2		76.9		55.6		55.6		45.5		MHz
	Internal feedback (f_{CNT}), T-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SST} + t_{COSi})$	100.0		87.0		71.4		52.6		52.6		43.5		MHz
	No feedback[2], Min of $1/(t_{WLS} + t_{WHS})$, $1/(t_{SS} + t_{HS})$ or $1/(t_{SST} + t_{HS})$	153.8		100.0		83.3		83.3		83.3		71.4		MHz
f_{MAXA}	External feedback, D-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SA} + t_{COA})$	76.9		62.5		52.6		38.5		38.5		33.3		MHz
	External feedback, T-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SAT} + t_{COA})$	71.4		58.8		50.0		37.0		37.0		32.3		MHz
	Internal feedback (f_{CNTA}), D-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SA} + t_{COAi})$	90.9		71.4		58.8		41.7		41.7		35.7		MHz
	Internal feedback (f_{CNTA}), T-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SAT} + t_{COAi})$	83.3		66.7		55.6		40.0		40.0		34.5		MHz
	No feedback[2], Min of $1/(t_{WLA} + t_{WHA})$, $1/(t_{SA} + t_{HA})$ or $1/(t_{SAT} + t_{HA})$	125.0		100.0		62.5		55.6		55.6		50.0		MHz
f_{MAXI}	Maximum input register frequency, Min of $1/(t_{WIRH} + t_{WIRL})$ or $1/(t_{SIRS} + t_{HIRS})$	111.0		100.0		83.3		83.3		83.3		71.4		MHz

Notes:

1. *See "Switching Test Circuit" in the General Information Section of the Vantis 1999 Data Book.*
2. *This parameter does not apply to flip-flops in the emulated mode since the feedback path is required for emulation.*

MACH 4A TIMING PARAMETERS OVER OPERATING RANGES[1]

		-5		-55		-65		-7		-10		-12		-14		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Combinatorial Delay:																
t_{PDi}	Internal combinatorial propagation delay		3.5		4.0		4.5		5.0		7.0		9.0		11.0	ns
t_{PD}	Combinatorial propagation delay		5.0		5.5		6.5		7.5		10.0		12.0		14.0	ns
Registered Delays:																
t_{SS}	Synchronous clock setup time, D-type register	3.0		3.5		3.5		5.0		5.5		7.0		10.0		ns
t_{SST}	Synchronous clock setup time, T-type register	4.0		4.0		4.0		6.0		6.5		8.0		11.0		ns
t_{SA}	Asynchronous clock setup time, D-type register	2.5		2.5		3.0		3.5		4.0		5.0		8.0		ns
t_{SAT}	Asynchronous clock setup time, T-type register	3.0		3.0		3.5		4.5		5.0		6.0		9.0		ns
t_{HS}	Synchronous clock hold time	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{HA}	Asynchronous clock hold time	2.5		2.5		3.0		3.5		4.0		5.0		8.0		ns
t_{COSi}	Synchronous clock to internal output		2.5		2.5		3.0		3.0		3.0		3.5		3.5	ns
t_{COS}	Synchronous clock to output		4.0		4.0		5.0		5.5		6.0		6.5		6.5	ns

MACH 4A TIMING PARAMETERS OVER OPERATING RANGES[1] (CONTINUED)

		-5		-55		-65		-7		-10		-12		-14		
		Min	**Max**	**Min**	**Max**	**Min**	**Max**	**Min**	**Max**	**Min**	**Max**	**Min**	**Max**	**Min**	**Max**	**Unit**
t_{COAi}	Asynchronous clock to internal output		5.0		5.0		5.0		6.0		8.0		10.0		12.0	ns
t_{COA}	Asynchronous clock to output		6.5		6.5		7.0		8.5		11.0		13.0		15.0	ns
Latched Delays:																
t_{SSL}	Synchronous latch setup time	4.0		4.0		4.5		6.0		7.0		8.0		10.0		ns
t_{SAL}	Asynchronous latch setup time	3.0		3.0		3.5		4.0		4.0		5.0		8.0		ns
t_{HSL}	Synchronous latch hold time	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{HAL}	Asynchronous latch hold time	3.0		3.0		3.5		4.0		4.0		5.0		8.0		ns
t_{PDLi}	Transparent latch to internal output		5.5		5.5		6.0		7.5		9.0		11.0		12.0	ns
t_{PDL}	Propagation delay through transparent latch to output		7.0		7.0		8.0		10.0		12.0		14.0		15.0	ns
t_{GOSi}	Synchronous gate to internal output		3.0		3.0		3.0		3.5		4.5		7.0		8.0	ns
t_{GOS}	Synchronous gate to output		4.5		4.5		5.0		6.0		7.5		10.0		11.0	ns
t_{GOAi}	Asynchronous gate to internal output		6.0		6.0		6.0		8.5		10.0		13.0		15.0	ns
t_{GOA}	Asynchronous gate to output		7.5		7.5		8.0		11.0		13.0		16.0		18.0	ns
Input Register Delays:																
t_{SIRS}	Input register setup time	1.5		1.5		2.0		2.0		2.0		2.0		2.0		ns
t_{HIRS}	Input register hold time	2.5		2.5		3.0		3.0		3.0		3.0		4.0		ns
t_{ICOSi}	Input register clock to internal feedback		3.0		3.0		3.0		3.5		4.5		6.0		6.0	ns
Input Latch Delays:																
t_{SIL}	Input latch setup time	1.5		1.5		2.0		2.0		2.0		2.0		2.0		ns
t_{HIL}	Input latch hold time	2.5		2.5		3.0		3.0		3.0		3.0		4.0		ns
t_{IGOSi}	Input latch gate to internal feedback		3.5		3.5		4.0		4.0		4.0		4.0		5.0	ns
t_{PDILi}	Transparent input latch to internal feedback		1.5		1.5		1.5		2.0		2.0		2.0		2.0	ns

MACH 4A TIMING PARAMETERS OVER OPERATING RANGES[1] (CONTINUED)

		-5		-55		-65		-7		-10		-12		-14		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Input Register Delays with ZHT Option:																
t_{SIRZ}	Input register setup time - ZHT	6.0		6.0		6.0		6.0		6.0		6.0		6.0		ns
t_{HIRZ}	Input register hold time - ZHT	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
Input Latch Delays with ZHT Option:																
t_{SILZ}	Input latch setup time - ZHT	6.0		6.0		6.0		6.0		6.0		6.0		6.0		ns
t_{HILZ}	Input latch hold time - ZHT	0.0		0.0		0.0		0.0		0.0		0.0		0.0		ns
t_{PDILZi}	Transparent input latch to internal feedback - ZHT		6.0		6.0		6.0		6.0		6.0		6.0		6.0	ns
Output Delays:																
t_{BUF}	Output buffer delay		1.5		1.5		2.0		2.5		3.0		3.0		3.0	ns
t_{SLW}	Slow slew rate delay adder		2.5		2.5		2.5		2.5		2.5		2.5		2.5	ns
t_{EA}	Output enable time		7.5		7.5		8.5		9.5		10.0		12.0		15.0	ns
t_{ER}	Output disable time		7.5		7.5		8.5		9.5		10.0		12.0		15.0	ns
Power Delay:																
t_{PL}	Power-down mode delay adder		2.5		2.5		2.5		2.5		2.5		2.5		2.5	ns
Reset and Preset Delays:																
t_{SRi}	Asynchronous reset or preset to internal register output		7.5		7.7		8.0		9.5		11.0		13.0		16.0	ns
t_{SR}	Asynchronous reset or preset to register output		9.0		9.2		10.0		12.0		14.0		16.0		19.0	ns
t_{SRR}	Asynchronous reset and preset register recovery time	7.0		7.0		7.5		8.0		8.0		10.0		15.0		ns
t_{SRW}	Asynchronous reset or preset width	7.0		7.0		8.0		10.0		10.0		12.0		15.0		ns
Clock/LE Width:																
t_{WLS}	Global clock width low	2.0		2.0		2.5		3.0		4.0		5.0		6.0		ns
t_{WHS}	Global clock width high	2.0		2.0		2.5		3.0		4.0		5.0		6.0		ns
t_{WLA}	Product term clock width low	3.0		3.0		3.5		4.0		5.0		8.0		9.0		ns
t_{WHA}	Product term clock width high	3.0		3.0		3.5		4.0		5.0		8.0		9.0		ns
t_{GWS}	Global gate width low (for low transparent) or high (for high transparent)	4.0		4.0		4.5		5.0		5.0		6.0		6.0		ns
t_{GWA}	Product term gate width low (for low transparent) or high (for high transparent)	4.0		4.0		4.5		5.0		5.0		6.0		9.0		ns
t_{WIRL}	Input register clock width low	3.0		3.0		3.5		4.0		5.0		6.0		6.0		ns
t_{WIRH}	Input register clock width high	3.0		3.0		3.5		4.0		5.0		6.0		6.0		ns
t_{WIL}	Input latch gate width	4.0		4.0		4.5		5.0		5.0		6.0		6.0		ns

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MACH 4A TIMING PARAMETERS OVER OPERATING RANGES[1] (CONTINUED)

		-5		-55		-65		-7		-10		-12		-14		
		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Unit
Frequency:																
f_{MAXS}	External feedback, D-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SS} + t_{COS})$	143		133		118		95.2		87.0		74.1		60.6		MHz
	External feedback, T-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SST} + t_{COS})$	125		125		111		87.0		80.0		69.0		57.1		MHz
	Internal feedback (f_{CNT}), D-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SS} + t_{COSi})$	182		167		154		125		118		95.0		74.1		MHz
	Internal feedback (f_{CNT}), T-type, Min of $1/(t_{WLS} + t_{WHS})$ or $1/(t_{SST} + t_{COSi})$	154		154		143		111		105		87.0		69.0		MHz
	No feedback[2], Min of $1/(t_{WLS} + t_{WHS})$, $1/(t_{SS} + t_{HS})$ or $1/(t_{SST} + t_{HS})$	250		250		200		154		125		100		83.3		MHz
f_{MAXA}	External feedback, D-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SA} + t_{COA})$	111		111		100		83.3		66.7		55.6		43.5		MHz
	External feedback, T-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SAT} + t_{COA})$	105		105		95.2		76.9		62.5		52.6		41.7		MHz
	Internal feedback (f_{CNTA}), D-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SA} + t_{COAi})$	133		133		125		105		83.3		66.7		50.0		MHz
	Internal feedback (f_{CNTA}), T-type, Min of $1/(t_{WLA} + t_{WHA})$ or $1/(t_{SAT} + t_{COAi})$	125		125		118		95.2		76.9		62.5		47.6		MHz
	No feedback[2], Min of $1/(t_{WLA} + t_{WHA})$, $1/(t_{SA} + t_{HA})$ or $1/(t_{SAT} + t_{HA})$	167		167		143		125		100		62.5		55.6		MHz
f_{MAXI}	Maximum input register frequency, Min of $1/(t_{WIRH} + t_{WIRL})$ or $1/(t_{SIRS} + t_{HIRS})$	167		167		143		125		100		83.3		83.3		MHz

Notes:

1. *See "Switching Test Circuit" in the General Information Section of the Vantis 1999 Data Book.*
2. *This parameter does not apply to flip-flops in the emulated mode since the feedback path is required for emulation.*

17466H-066

CAPACITANCE [1]

Parameter Symbol	Parameter Description	Test Conditions		Typ	Unit
C_{IN}	Input capacitance	V_{IN}=2.0 V	3.3 V or 5 V, 25°C, 1 MHz	6	pF
$C_{I/O}$	Output capacitance	V_{OUT}=2.0V	3.3 V or 5 V, 25°C, 1 MHz	8	pF

Note:

1. *These parameters are not 100% tested, but are calculated at initial characterization and at any time the design is modified where this parameter may be affected.*

I_{CC} vs. FREQUENCY

These curves represent the typical power consumption for a particular device at system frequency. The selected "typical" pattern is a 16-bit up-down counter. This pattern fills the device and exercises every macrocell. Maximum frequency shown uses internal feedback and a D-type register. Power/Speed are optimized to obtain the highest counter frequency and the lowest power. The highest frequency (LSBs) is placed in common PAL blocks, which are set to high power. The lowest frequency signals (MSBs) are placed in a common PAL block and set to lowest power.

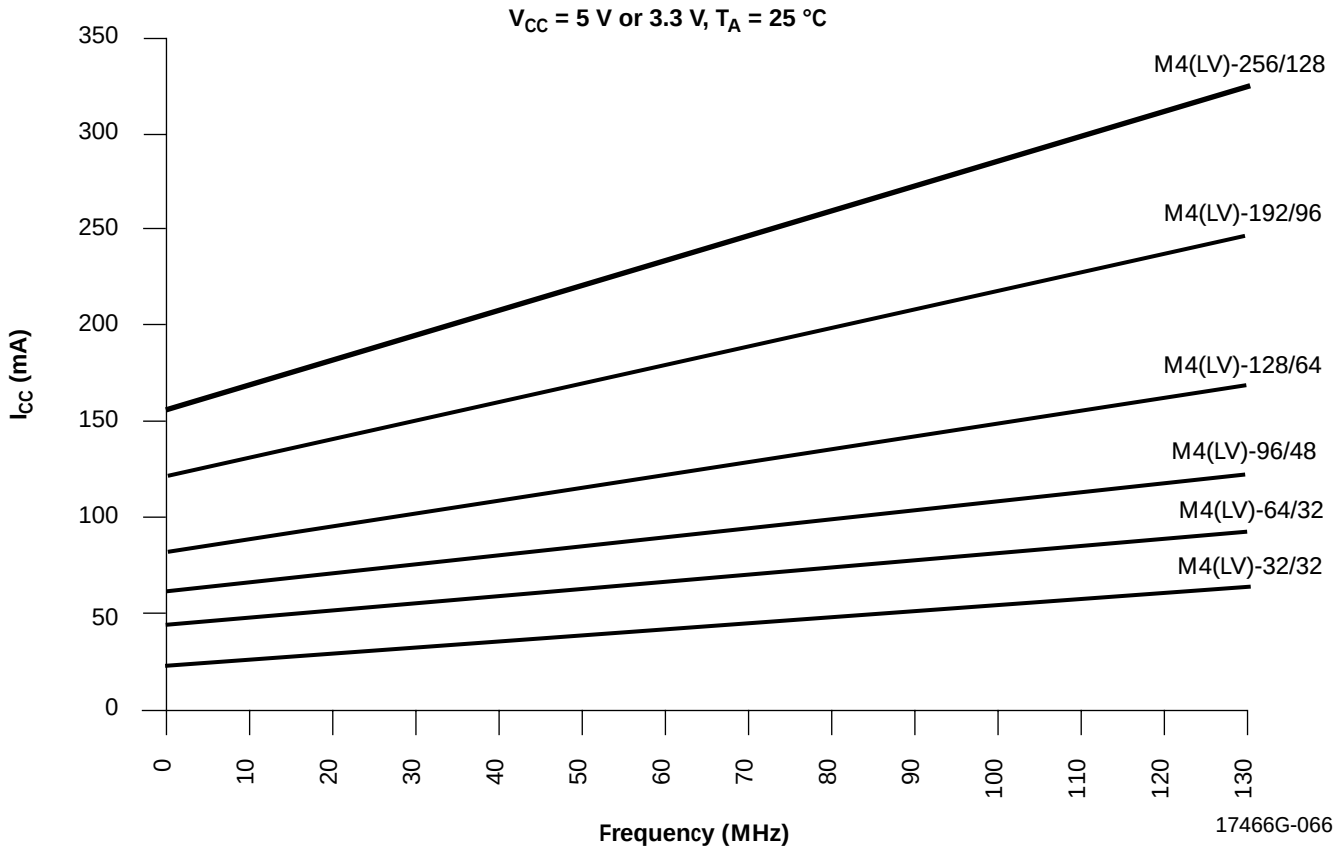


Figure 19. I_{CC} Curves at High Power Mode

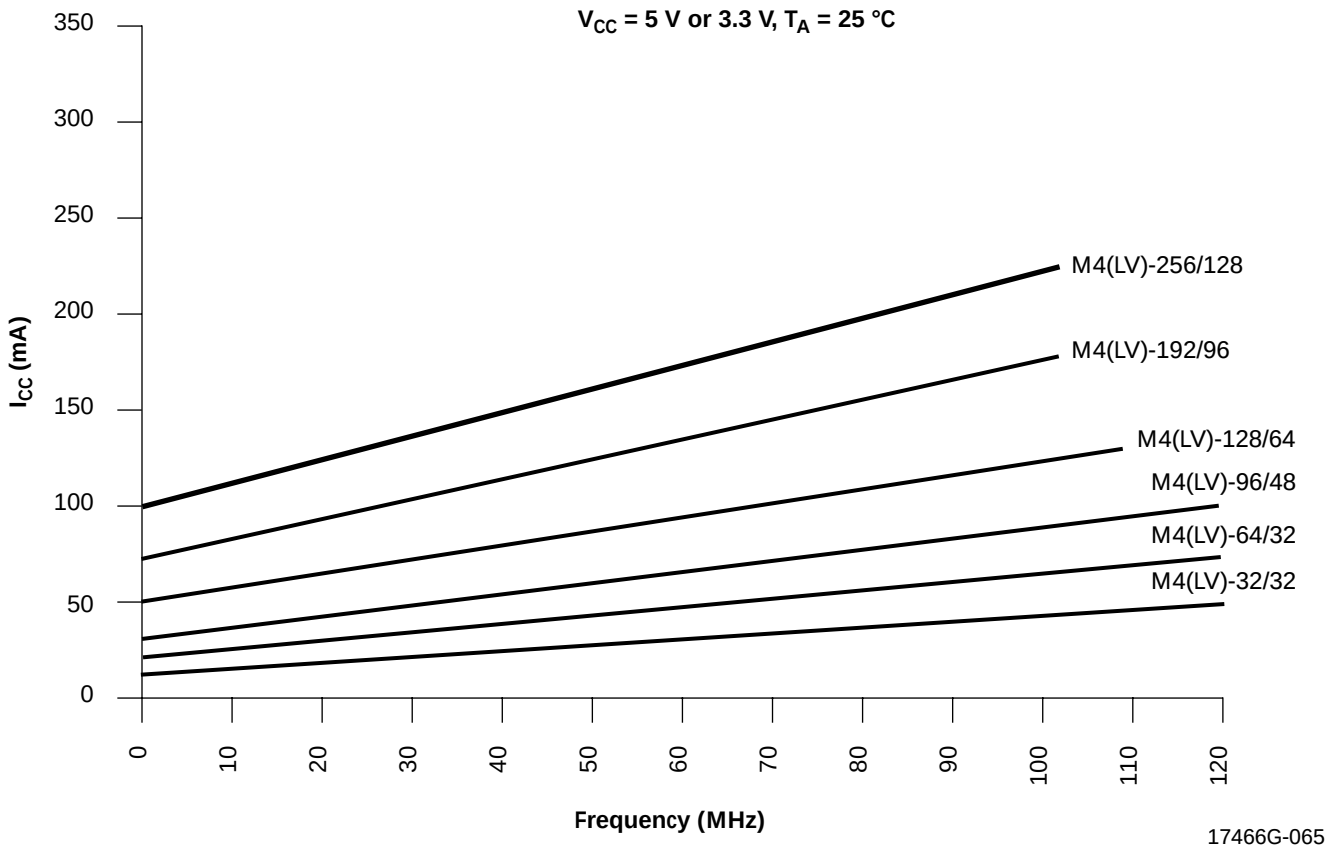


Figure 20. I_{CC} Curves at Low Power Mode

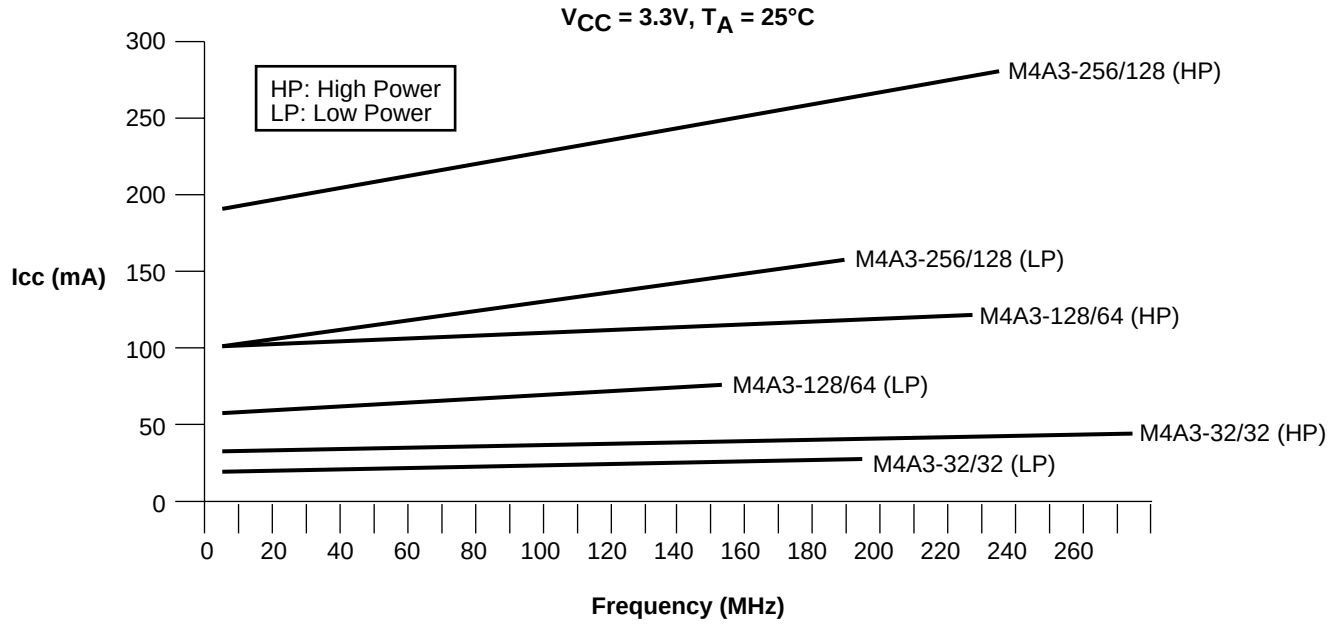
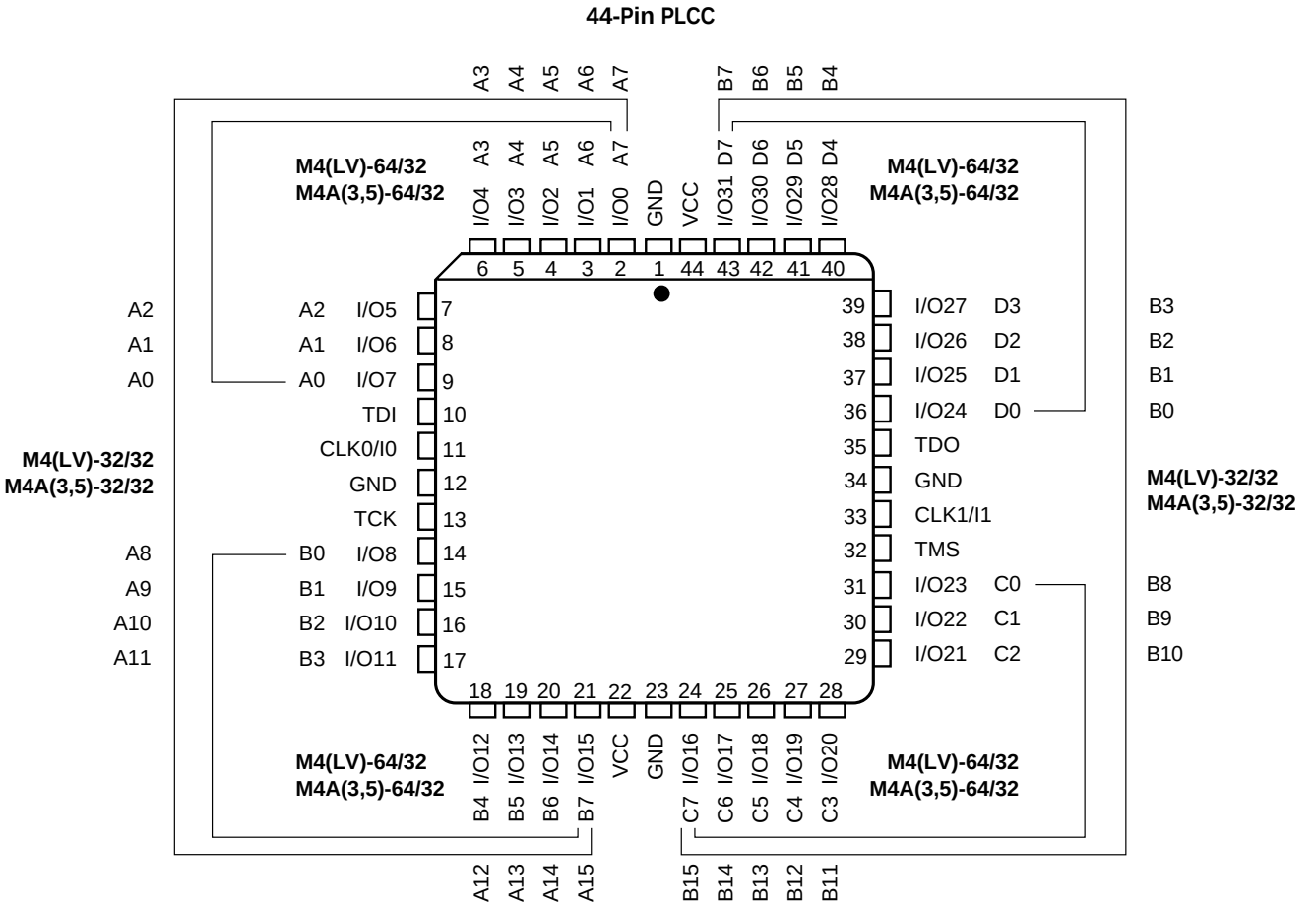


Figure 21. MACH 4A Device Dynamic Icc Curves at High and Low Power Modes

44-PIN PLCC CONNECTION DIAGRAM (M4(LV)-32/32, M4A(3,5)-32/32, M4(LV)-64/32 AND M4A(3,5)-64/32)

Top View



17466G-026

PIN DESIGNATIONS

CLK/I = Clock or Input

GND = Ground

I/O = Input/Output

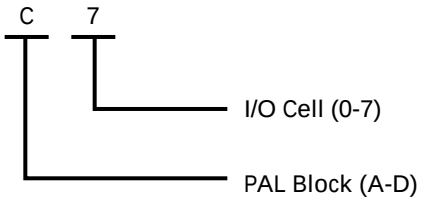
V_{CC} = Supply Voltage

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

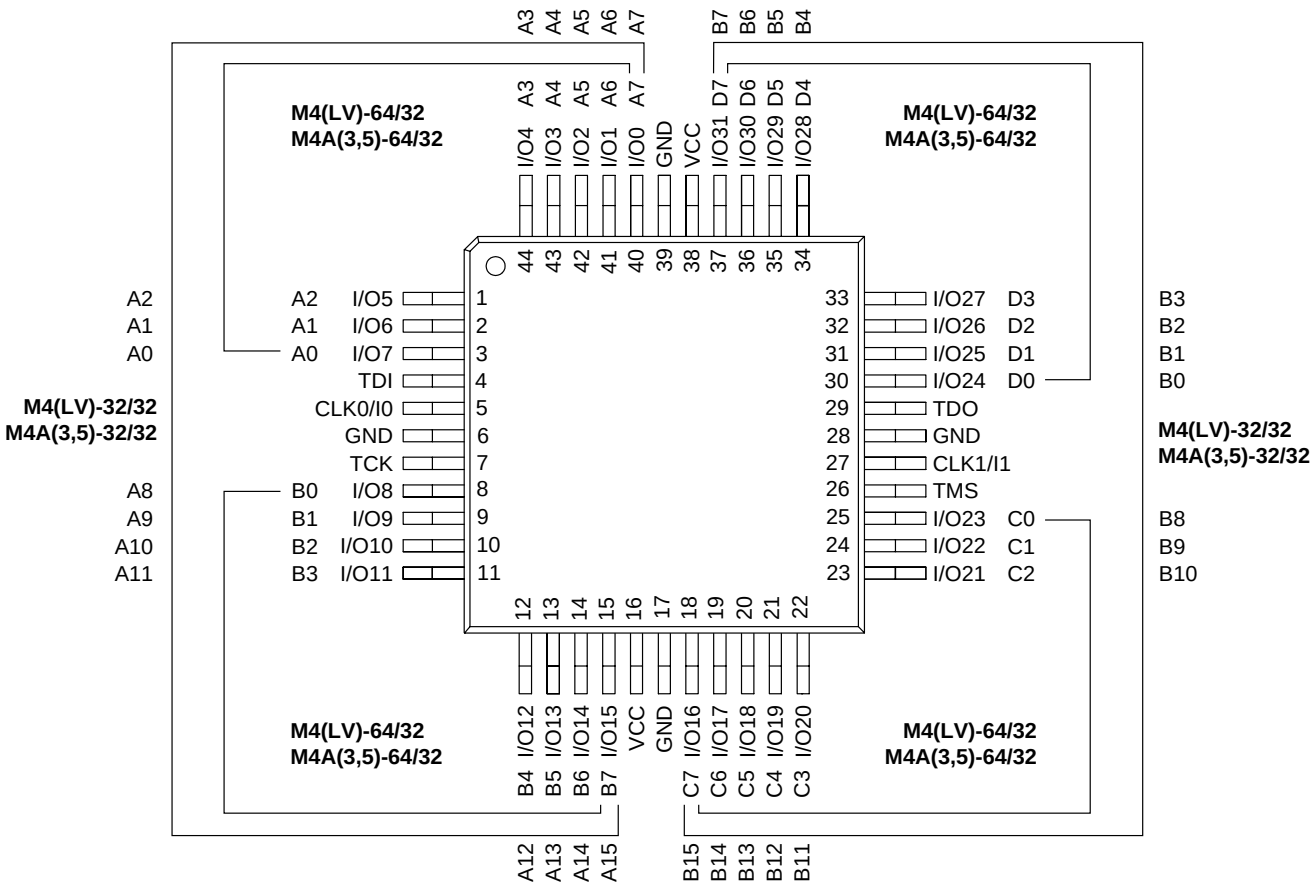
TDO = Test Data Out



44-PIN TQFP CONNECTION DIAGRAM (M4(LV)-32/32, M4A(3,5)-32/32, M4(LV)-64/32 AND M4A(3,5)-64/32)

Top View

44-Pin TQFP



PIN DESIGNATIONS

CLK/I = Clock or Input

GND = Ground

I/O = Input/Output

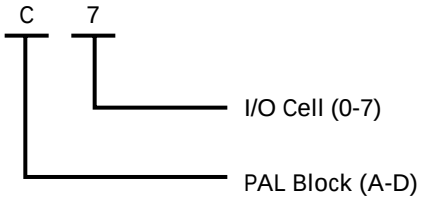
V_{CC} = Supply Voltage

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

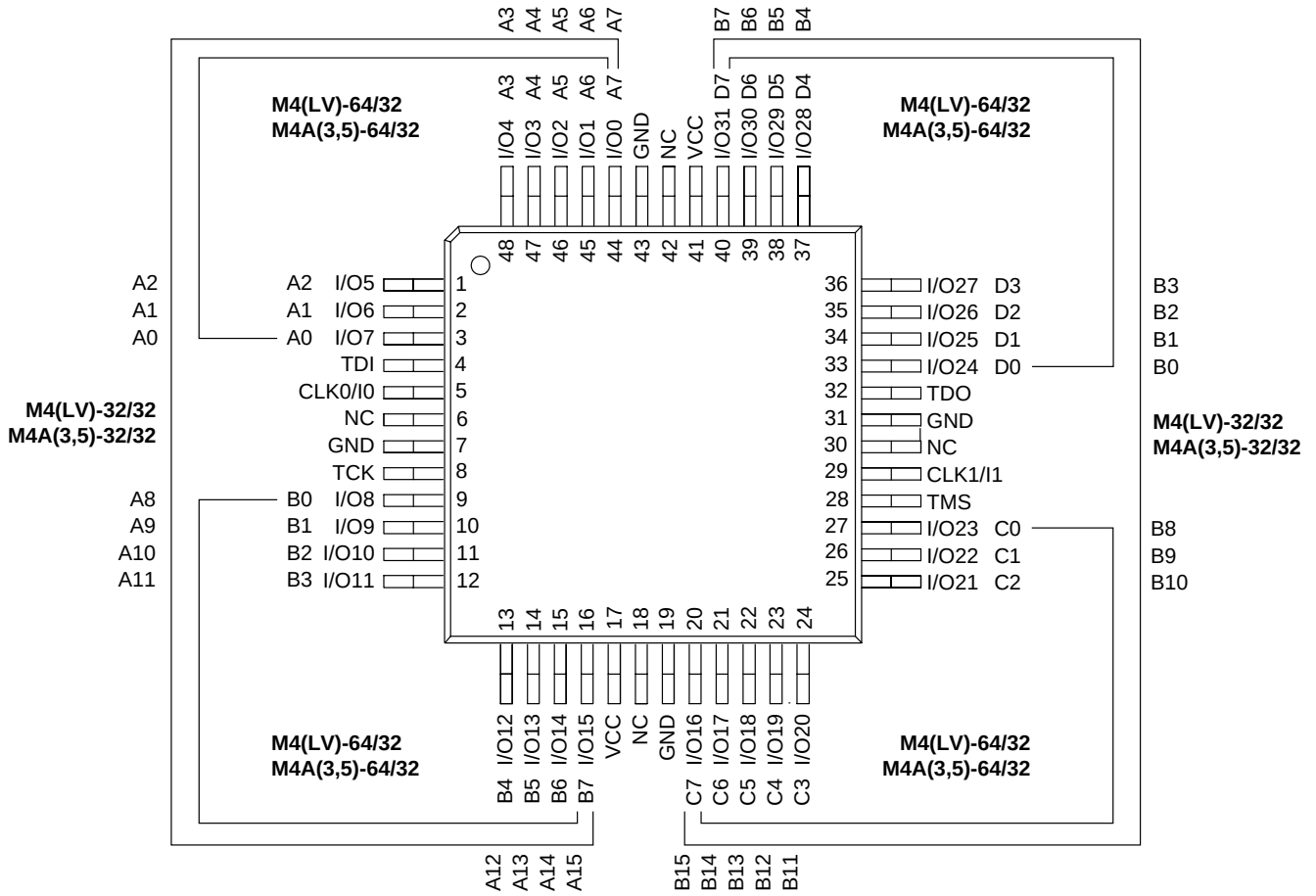
TDO = Test Data Out



48-PIN TQFP CONNECTION DIAGRAM (M4(LV)-32/32, M4A(3,5)-32/32, M4(LV)-64/32 AND M4A(3,5)-64/32)

Top View

48-Pin TQFP



17466G-028

PIN DESIGNATIONS

CLK/I = Clock or Input

GND = Ground

I/O = Input/Output

V_{CC} = Supply Voltage

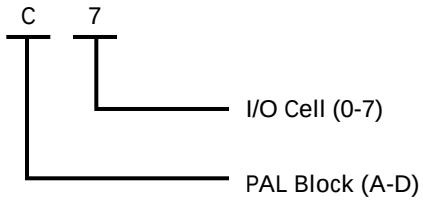
NC = No Connect

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

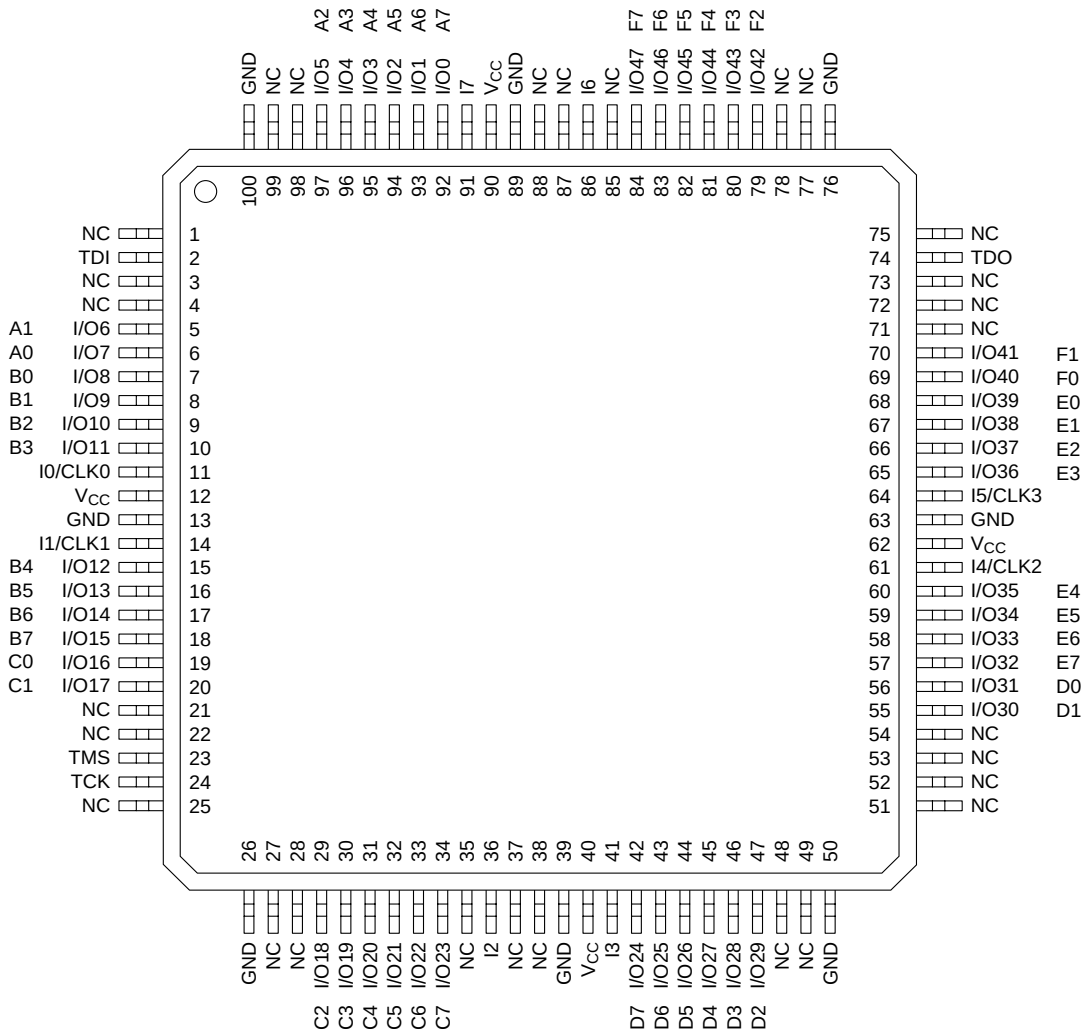
TDO = Test Data Out



100-PIN TQFP CONNECTION DIAGRAM (M4(LV)-96/48 AND M4A(3,5)-96/48)

Top View

100-Pin TQFP



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PIN DESIGNATIONS

CLK/I = Clock or Input

GND = Ground

I = Input

I/O = Input/Output

V_{CC} = Supply Voltage

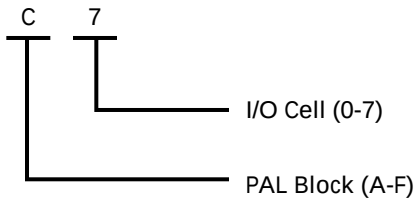
NC = No Connect

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

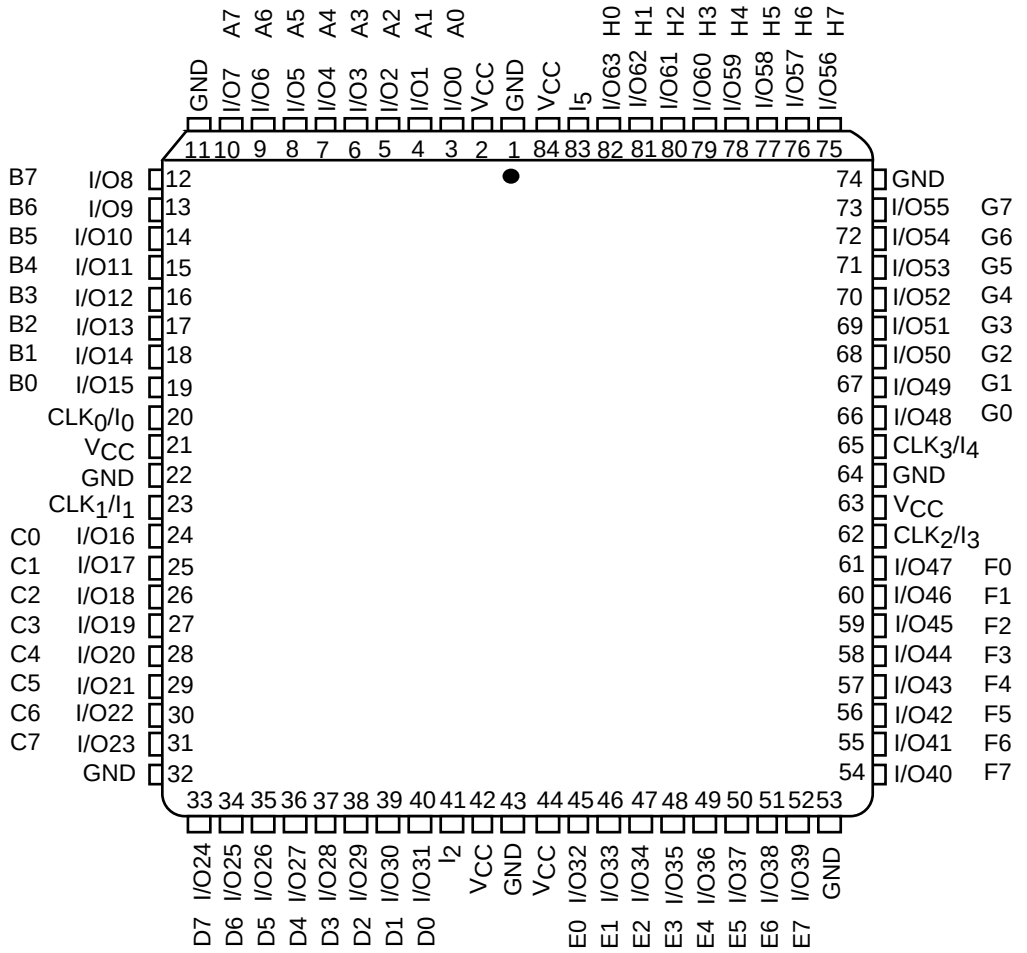
TDO = Test Data Out



84-PIN PLCC CONNECTION DIAGRAM (M4(LV)-128N/64)

Top View

84-Pin PLCC



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Note:
Pin-compatible with the MACH131, MACH231, MACH435.

PIN DESIGNATIONS

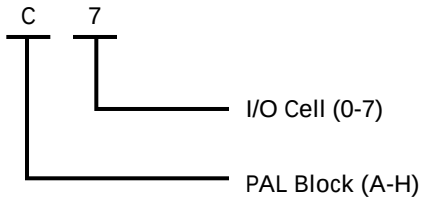
CLK/I = Clock or Input

GND = Ground

I = Input

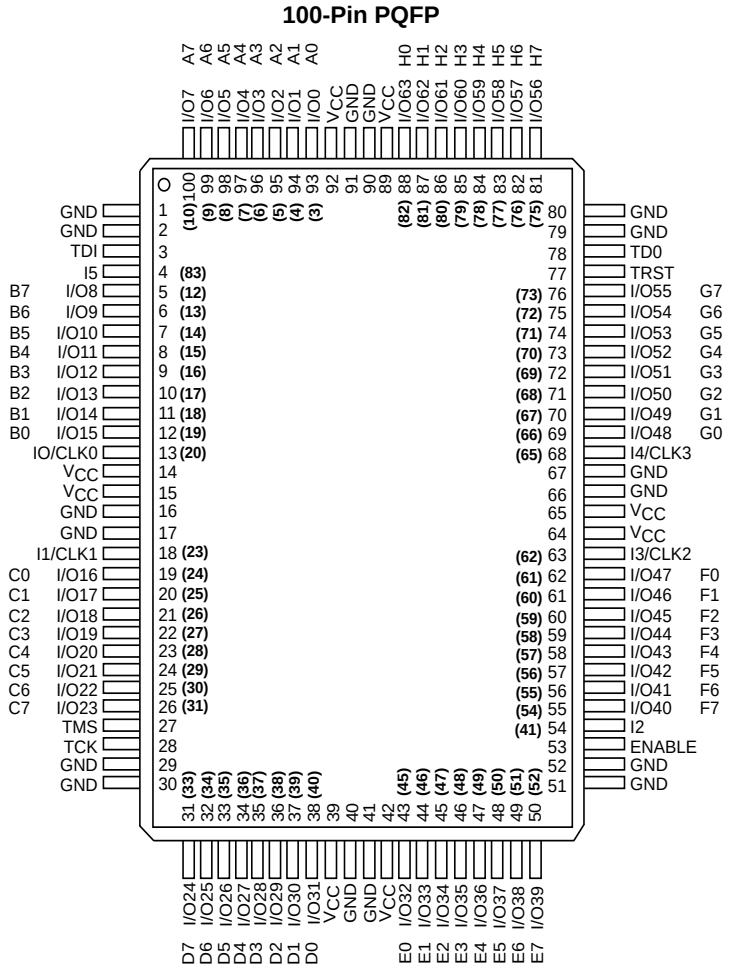
I/O = Input/Output

V_{CC} = Supply Voltage



100-PIN PQFP CONNECTION DIAGRAM (M4(LV)-128/64 AND M4A(3,5)-128/64)

Top View



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Note:
The numbers in parentheses reflect compatible pin numbers for 84-pin PLCC.

PIN DESIGNATIONS

I/CLK = Input or Clock

GND = Ground

I = Input

I/O = Input/Output

V_{CC} = Supply Voltage

TDI = Test Data In

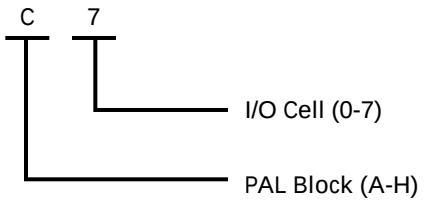
TCK = Test Clock

TMS = Test Mode Select

TDO = Test Data Out

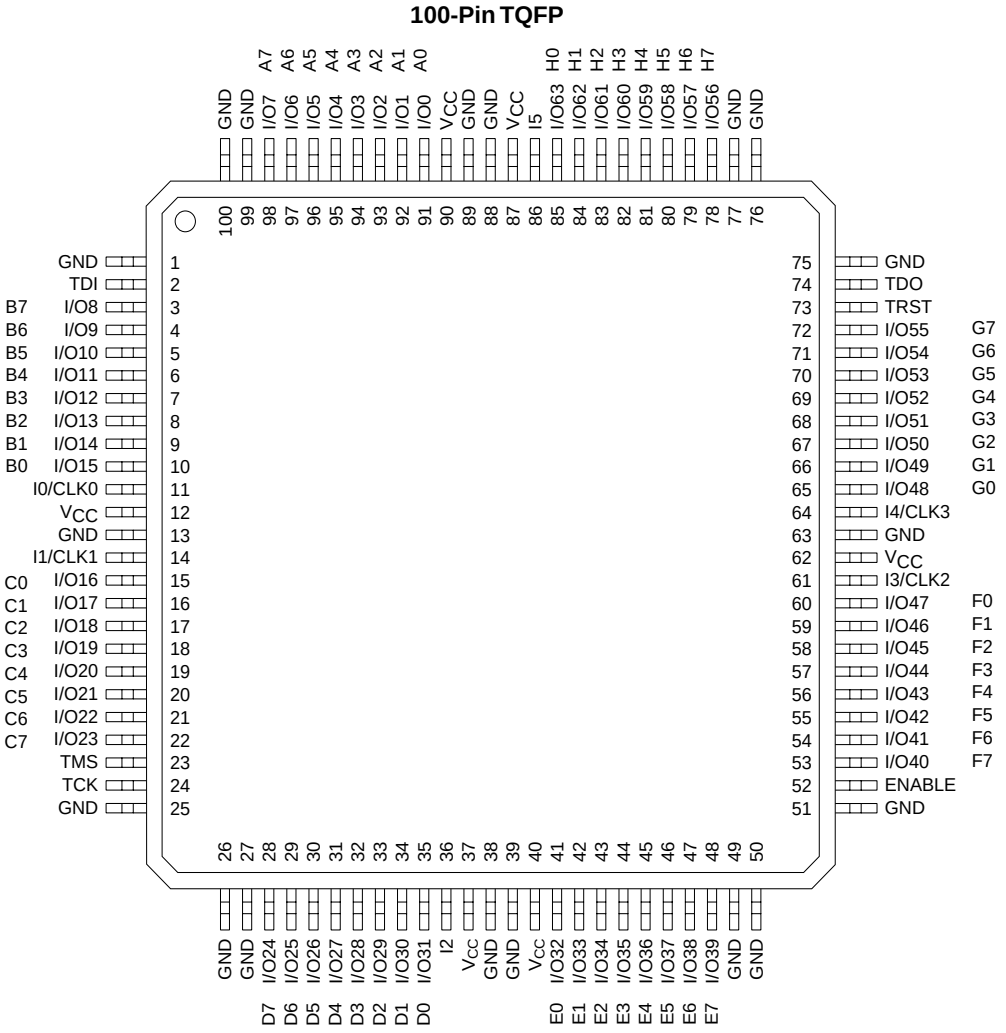
TRST = Test Reset

ENABLE = Program



100-PIN TQFP CONNECTION DIAGRAM (M4(LV)-128/64 AND M4A(3,5)-128/64)

Top View



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PIN DESIGNATIONS

CLK/I = Clock or Input

GND = Ground

I = Input

I/O = Input/Output

V_{CC} = Supply Voltage

TDI = Test Data In

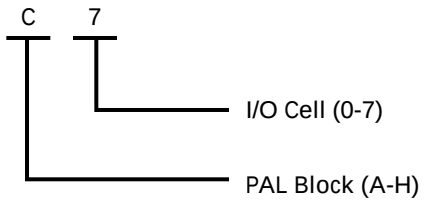
TCK = Test Clock

TMS = Test Mode Select

TDO = Test Data Out

TRST = Test Reset

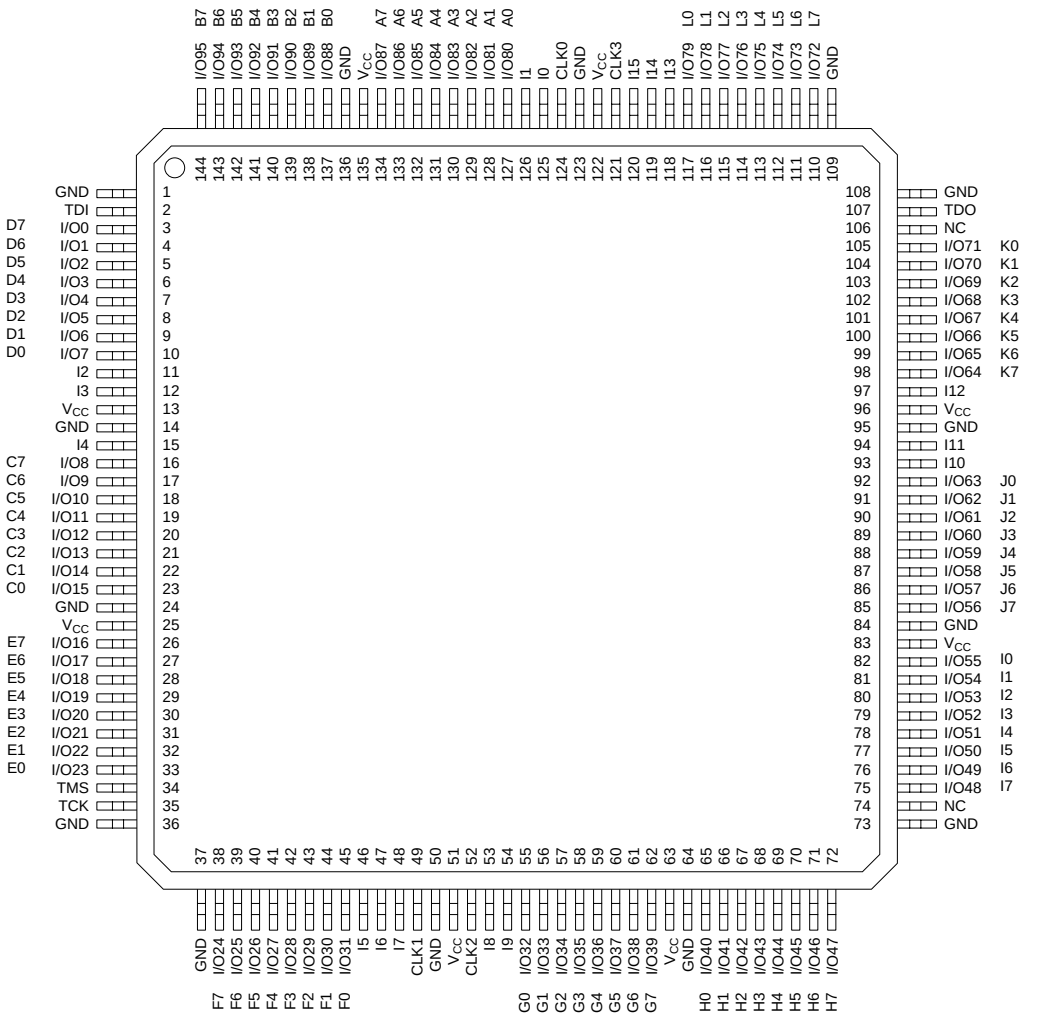
ENABLE = Program



144-PIN TQFP CONNECTION DIAGRAM (M4(LV)-192/96 AND M4A(3,5)-192/96)

Top View

144-Pin TQFP



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PIN DESIGNATIONS

CLK = Clock

GND = Ground

I = Input

I/O = Input/Output

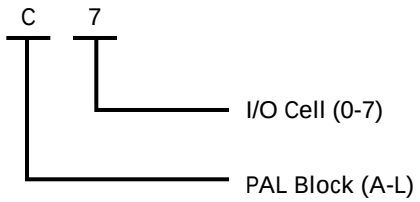
V_{CC} = Supply Voltage

TDI = Test Data In

TCK = Test Clock

TMS = Test Mode Select

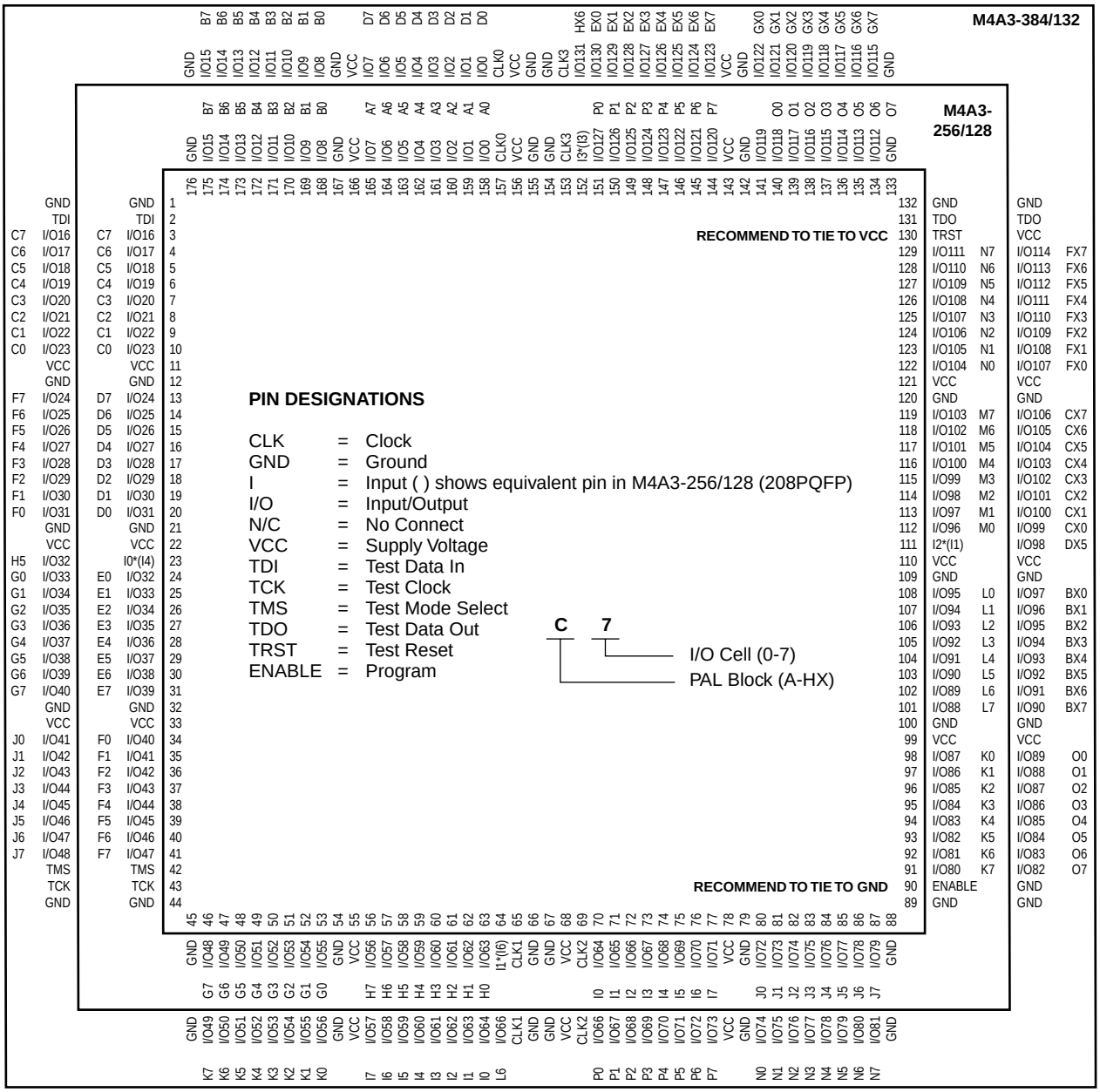
TDO = Test Data Out



176-PIN TQFP CONNECTION DIAGRAM - M4A3-256/128, M4A3-192/128, M4A3-128/128, AND M4A3-384/132

Top View

176-Pin TQFP



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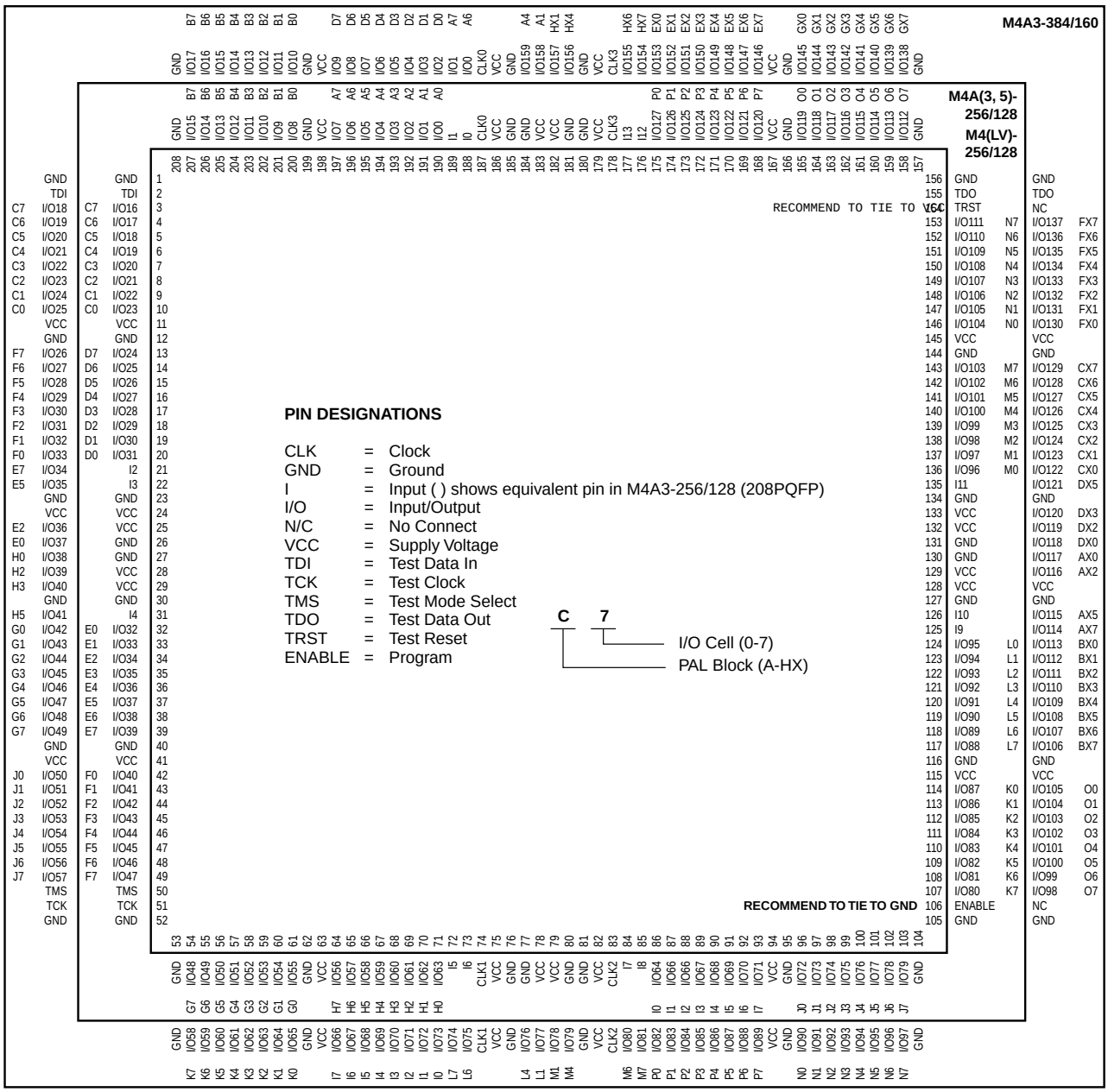
208-PIN PQFP CONNECTION DIAGRAM - M4A3-256/128, M4-256/128, M4LV-256/128, AND M4A3-384/160

Top View

208-Pin PQFP



17466G-044

256-BALL BGA CONNECTION DIAGRAM (M4(LV)-256/128 AND M4A(3,5)-256/128)

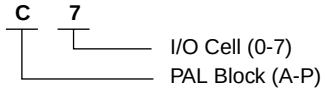
Bottom View

256-Ball BGA

	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	
A	GND	N/C	GND	I/O108 N4	I/O105 N1	GND	I/O100 M4	I/O96 M0	GND	GND	GND	GND	I/O95 L0	I/O91 L4	GND	I/O87 K0	N/C	GND	GND	GND	A
B	GND	I/O113 O6	N/C	I/O109 N5	I/O106 N2	I/O103 M7	I/O102 M6	I/O98 M2	N/C	I11	N/C	N/C	I/O93 L2	I/O89 L6	I/O88 L7	I/O85 K2	I/O83 K6	I/O82 K5	N/C	GND	B
C	I/O116 O3	N/C	VCC	TRST	I/O111 N7	I/O107 N3	I/O104 N0	I/O101 M5	I/O97 M1	N/C	I10	I/O94 L1	I/O90 L5	I/O86 K1	I/O84 K3	I/O80 K7	ENABLE	VCC	I/O78 J6	I/O74 J2	C
D	I/O120 P7	I/O117 O2	I/O112 O7	VCC	VCC	I/O110 N6	VCC	N/C	I/O99 M3	N/C	I9	I/O92 L3	N/C	VCC	I/O81 K6	VCC	VCC	I/O79 J7	I/O75 J3	I/O71 I7	D
E	I/O123 P4	I/O119 O0	I/O114 O5	TDI													TDO	I/O77 J5	I/O72 J0	I/O68 I4	E
F	GND	I/O122 P5	I/O118 O1	I/O115 O4													I/O76 J4	I/O73 J1	I/O69 I5	GND	F
G	I12	I/O125 P2	I/O121 P6	VCC													VCC	I/O70 I6	I/O65 I1	I8	G
H	GND	I/O127 P0	I/O126 P1	I/O124 P3													I/O67 I3	I/O66 I2	I/O64 I0	GND	H
J	N/C	N/C	N/C	I13													I7	N/C	N/C	N/C	J
K	GND	CLK3	N/C	N/C													N/C	N/C	CLK2	N/C	K
L	N/C	CLK0	N/C	N/C													N/C	N/C	CLK1	GND	L
M	N/C	N/C	N/C	I0													I6	N/C	I/O63 H0	I/O62 H1	M
N	GND	I/O0 A0	I/O2 A2	I/O3 A3													I/O60 H3	I/O61 H2	I/O59 H4	GND	N
P	I1	I/O1 A1	I/O6 A6	VCC													VCC	I/O57 H6	I/O58 H5	I5	P
R	GND	I/O5 A5	I/O9 B1	N/C													I/O51 G4	I/O54 G1	I/O56 H7	GND	R
T	I/O4 A4	I/O8 B0	I/O12 B4	TCK													TMS	I/O50 G5	I/O55 G0	N/C	T
U	I/O7 A7	I/O11 B3	I/O15 B7	VCC	VCC	I/O18 C5	VCC	I/O24 D7	I/O29 D2	I2	N/C	I/O35 E3	N/C	VCC	N/C	VCC	VCC	I/O48 G7	I/O53 G2	N/C	U
V	I/O10 B2	I/O13 B5	VCC	I/O16 C7	I/O17 C6	I/O21 C2	I/O23 C0	I/O27 D4	I/O31 D0	I3	N/C	I/O33 E1	I/O37 E5	I/O41 F1	I/O43 F3	I/O46 F6	I/O47 F7	VCC	I/O52 G3	N/C	V
W	GND	I/O14 B6	N/C	N/C	I/O19 C4	I/O22 C1	I/O25 D6	I/O28 D3	N/C	N/C	I4	N/C	I/O34 E2	I/O38 E6	I/O39 E7	I/O42 F2	I/O45 F5	N/C	I/O49 G6	GND	W
Y	GND	GND	GND	N/C	I/O20 C3	GND	I/O26 D5	I/O30 D1	GND	GND	GND	GND	I/O32 E0	I/O36 E4	GND	I/O40 F0	I/O44 F4	GND	N/C	GND	Y
	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	

PIN DESIGNATIONS

CLK	=	Clock
GND	=	Ground
I	=	Input
I/O	=	Input/Output
N/C	=	No Connect
VCC	=	Supply Voltage
TDI	=	Test Data In
TCK	=	Test Clock
TMS	=	Test Mode Select
TDO	=	Test Data Out
TRST	=	Test Reset
ENABLE	=	Program



17466G-045

256-BALL BGA CONNECTION DIAGRAM - M4A3-384/192

Bottom View

256-Ball BGA

	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	
A	GND	I/O11 FX7	GND	I/O44 FX6	I/O58 CX6	GND	I/O70 CX2	I/O76 DX6	GND	GND	GND	GND	I/O108 AX5	I/O116 BX0	GND	I/O128 BX7	I/O134 O3	GND	GND	GND	A
B	GND	I/O12 GX7	I/O28 FX5	I/O45 FX3	I/O59 CX7	I/O64 CX5	I/O71 CX3	I/O77 DX7	I/O84 DX5	I/O90 DX2	I/O96 AX0	I/O102 AX3	I/O109 AX6	I/O117 BX1	I/O122 BX4	I/O129 BX6	I/O135 O4	I/O148 O6	I/O164 O7	GND	B
C	I/O0 GX6	I/O13 GX5	VCC	I/O46 FX4	I/O60 FX2	I/O65 FX1	I/O72 CX4	I/O78 CX0	I/O85 DX4	I/O91 DX1	I/O97 AX1	I/O103 AX4	I/O110 BX2	I/O118 BX5	I/O123 O0	I/O130 O1	I/O136 O5	VCC	I/O165 N7	I/O181 N6	C
D	I/O1 EX7	I/O14 GX3	I/O29 GX4	VCC	VCC	I/O66 FX0	VCC	I/O79 CX1	I/O86 DX3	I/O92 DX0	I/O98 AX2	I/O104 AX7	I/O111 BX3	VCC	I/O124 O2	VCC	VCC	I/O149 N4	I/O166 N5	I/O182 P7	D
E	I/O2 EX0	I/O15 GX0	I/O30 GX1	TDI													TDO	I/O150 N2	I/O167 N3	I/O183 P6	E
F	GND	I/O16 EX1	I/O31 EX6	I/O47 GX2													I/O137 N1	I/O151 N0	I/O168 P5	GND	F
G	I/O3 HX6	I/O17 EX4	I/O32 EX5	VCC													VCC	I/O152 P4	I/O169 P3	I/O184 M7	G
H	GND	I/O18 HX5	I/O33 EX2	I/O48 EX3													I/O138 P2	I/O153 P1	I/O170 P0	GND	H
J	I/O4 HX0	I/O19 HX1	I/O34 HX4	I/O49 HX7													I/O139 M6	I/O154 M5	I/O171 M4	I/O185 M3	J
K	GND	CLK3	I/O35 HX2	I/O50 HX3													I/O140 M0	I/O155 M1	CLK2	I/O186 M2	K
L	I/O5 A2	CLK0	I/O36 A0	I/O51 A1													I/O141 L3	I/O156 L4	CLK1	GND	L
M	I/O6 A4	I/O20 A3	I/O37 A5	I/O52 A6													I/O142 L6	I/O157 L5	I/O172 L0	I/O187 L1	M
N	GND	I/O21 A7	I/O38 D0	I/O53 D1													I/O143 I5	I/O158 I0	I/O173 L7	GND	N
P	I/O7 D2	I/O22 D3	I/O39 D4	VCC													VCC	I/O159 I4	I/O174 I1	I/O188 L2	P
R	GND	I/O23 D5	I/O40 D6	I/O54 D7													I/O144 K5	I/O160 K0	I/O175 I3	GND	R
T	I/O8 B3	I/O24 B0	I/O41 B7	TCK													TMS	I/O161 K4	I/O176 K1	I/O189 I2	T
U	I/O9 B4	I/O25 B1	I/O42 B6	VCC	VCC	I/O67 C0	VCC	I/O80 F0	I/O87 E5	I/O93 E2	I/O99 H2	I/O105 H5	I/O112 G0	VCC	I/O125 J1	VCC	VCC	I/O162 K7	I/O177 K2	I/O190 I6	U
V	I/O10 B5	I/O26 B2	VCC	I/O55 C5	I/O61 C2	I/O68 C1	I/O73 F4	I/O81 F1	I/O88 E4	I/O94 E1	I/O100 H1	I/O106 H4	I/O113 G1	I/O119 G4	I/O126 J0	I/O131 J2	I/O145 J5	VCC	I/O178 K3	I/O191 I7	V
W	GND	I/O27 C7	I/O43 C6	I/O56 C3	I/O62 F7	I/O69 F5	I/O74 F3	I/O82 E7	I/O89 E3	I/O95 E0	I/O101 H0	I/O107 H3	I/O114 H7	I/O120 G3	I/O127 G5	I/O132 G7	I/O146 J4	I/O163 J6	I/O179 J7	GND	W
Y	GND	GND	GND	I/O57 C4	I/O63 F6	GND	I/O75 F2	I/O83 E6	GND	GND	GND	GND	I/O115 H6	I/O121 G2	GND	I/O133 G6	I/O147 J3	GND	I/O180 K6	GND	Y
	20	19	18	17	16	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	

PIN DESIGNATIONS

CLK	=	Clock
GND	=	Ground
I	=	Input
I/O	=	Input/Output
N/C	=	No Connect
VCC	=	Supply Voltage
TDI	=	Test Data In
TCK	=	Test Clock
TMS	=	Test Mode Select
TDO	=	Test Data Out

C 7
I/O Cell (0-7)
PAL Block (A-HX)

17466G-046

MACH 4 PRODUCT ORDERING INFORMATION

MACH 4 Devices Commercial & Industrial - 3.3V and 5V

Lattice/Vantis programmable logic products are available with several ordering options. The order number (Valid Combination) is formed by a combination of:

M4- 256 / 128 -7 Y C 48

FAMILY TYPE

M4- = MACH 4 Family (5-V V_{CC})
M4LV- = MACH 4 Family Low Voltage (3.3-V V_{CC})

MACROCELL DENSITY

32 = 32 Macrocells
64 = 64 Macrocells
96 = 96 Macrocells
128 = 128 Macrocells
128N = 128 Macrocells, Non-ISP
192 = 192 Macrocells
256 = 256 Macrocells

I/Os

/32 = 32 I/Os in 44-pin PLCC, 44-pin TQFP or 48-pin TQFP
/48 = 48 I/Os in 100-pin TQFP
/64 = 64 I/Os in 84-pin PLCC, 100-pin PQFP or 100-pin TQFP
/96 = 96 I/Os in 144-pin TQFP
/128 = 128 I/Os in 208-pin PQFP or 256-ball BGA

SPEED

-7 = 7.5 ns t_{PD}
-10 = 10 ns t_{PD}
-12 = 12 ns t_{PD}
-14 = 14 ns t_{PD}
-15 = 15 ns t_{PD}
-18 = 18 ns t_{PD}

PACKAGE TYPE

A = Ball Grid Array (BGA)
J = Plastic Leaded Chip Carrier (PLCC)
V = Thin Quad Flat Pack (TQFP)
Y = Plastic Quad Flat Pack (PQFP)

OPERATING CONDITIONS

C = Commercial (0°C to +70°C)
I = Industrial (-40 °C to +85 °C)

48 = 48-pin TQFP for M4(LV)-32/32 or M4(LV)-64/32

Valid Combinations		
M4-32/32	-7, -10, -12, -15	JC, VC, VC48
M4LV-32/32		JC, VC, VC48
M4-64/32		JC, VC, VC48
M4LV-64/32		JC, VC, VC48
M4-96/48		VC
M4LV-96/48		VC
M4-128/64		YC, VC
M4LV-128/64		YC, VC
M4-128N/64		JC
M4LV-128N/64		JC
M4-192/96		VC
M4LV-192/96		VC
M4-256/128		YC, AC
M4LV-256/128		YC, AC

All MACH devices are dual-marked with both Commercial and Industrial grades. The Industrial speed grade is slower, i.e., M4-256/128-7YC-10YI

Valid Combinations		
M4-32/32	-10, -12, -14, -18	JI, VI, VI48
M4LV-32/32		JI, VI, VI48
M4-64/32		JI, VI, VI48
M4LV-64/32		JI, VI, VI48
M4-96/48		VI
M4LV-96/48		VI
M4-128/64		YI, VI
M4LV-128/64		YI, VI
M4-128N/64		JI
M4LV-128N/64		JI
M4-192/96		VI
M4LV-192/96		VI
M4-256/128		YI, AI
M4LV-256/128		YI, AI

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Lattice/Vantis sales office to confirm availability of specific valid combinations and to check on newly released combinations.

MACH 4A PRODUCT ORDERING INFORMATION

MACH 4A Devices Commercial and Industrial - 3.3V and 5V

Lattice/Vantis programmable logic products are available with several ordering options. The order number (Valid Combination) is formed by a combination of:

M4A3- 256 / 128 -7 Y C

FAMILY TYPE

M4A3- = MACH 4 Family Low Voltage Advanced Feature (3.3-V V_{CC})
M4A5- = MACH 4 Family Advanced Feature (5-V V_{CC})

MACROCELL DENSITY

32	=	32 Macrocells	192	=	192 Macrocells
64	=	64 Macrocells	256	=	256 Macrocells
96	=	96 Macrocells	84	=	384 Macrocells
128	=	128 Macrocells	512	=	512 Macrocells

I/Os

/32 = 32 I/Os in 44-pin PLCC, 44-pin TQFP or 48-pin TQFP
/48 = 48 I/Os in 100-pin TQFP
/64 = 64 I/Os in 100-pin TQFP, 100-pin PQFP, or 100-ball caBGA
/96 = 96 I/Os in 144-pin TQFP or 144-ball fpBGA
/128 = 128 I/Os in 176-pin TQFP, 208-ball fpBGA, 208-pin PQFP, or 256-ball BGA
/132 = 132 I/Os in 176-pin TQFP
/160 = 160 I/Os in 208-pin PQFP
/192 = 192 I/Os in 256-ball BGA or 256-ball fpBGA
/256 = 256 I/Os in 388-ball fpBGA

SPEED

-5 = 5.0 ns t_{PD}
-55 = 5.5 ns t_{PD}
-65 = 6.5 ns t_{PD}
-7 = 7.5 ns t_{PD}
-10 = 10 ns t_{PD}
-12 = 12 ns t_{PD}
-14 = 14 ns t_{PD}

PACKAGE TYPE

A = Ball Grid Array (BGA)
J = Plastic Leaded Chip Carrier (PLCC)
V = Thin Quad Flat Pack (TQFP)
Y = Plastic Quad Flat Pack (PQFP)
FA = Fine-pitch Ball Grid Array (fpBGA)
FA = Chip-array Ball Grid Array (caBGA)

OPERATING CONDITIONS

C = Commercial (0°C to +70°C)
I = Industrial (-40 °C to +85 °C)

48 = 48-pin TQFP for M4A3-32/32 or M4A3-64/32 M4A5-32/32 or M4A5-64/32

3.3V Commercial Combinations		
M4A3-32/32	-5, -7, -10	JC, VC, VC48
M4A3-64/32	-55, -7, -10	JC, VC, VC48
M4A3-96/48		VC
M4A3-128/64		YC, VC, FAC
M4A3-192/96	-65, -7, -10	VC, FAC
M4A3-256/128		YC, VC, AC, FAC
M4A3-256/160		YC
M4A3-256/192		FAC
M4A3-384/132	-7, -10, -12	VC
M4A3-384/160		YC
M4A3-384/192		AC
M4A3-512/132		VC
M4A3-512/160		YC
M4A3-512/192		AC
M4A3-512/256		FAC

3.3V Industrial Combinations		
M4A3-32/32	-7, -10, -12	JI, VI, VI48
M4A3-64/32		JI, VI, VI48
M4A3-96/48		VI
M4A3-128/64		YI, VI, FAI
M4A3-192/96	-10, -12	VI
M4A3-256/128		YI, VI, AI, FAI
M4A3-256/160		YI
M4A3-256/192		FAI
M4A3-384/132	-10, -12, -14	VI
M4A3-384/160		YI
M4A3-384/192		AI
M4A3-512/132		VI
M4A3-512/160		YI
M4A3-512/192		AI
M4A3-512/256		FAI

5V Commercial Combinations		
M4A5-32/32	-5, -7, -10,	JC, VC, VC48
M4A5-64/32	-55, -7, -10	JC, VC, VC48
M4A5-96/48		VC
M4A5-128/64		YC, VC
M4A5-192/96	-65, -7, -10	VC
M4A5-256/128		YC, AC

5V Industrial Combinations		
M4A5-32/32	-7, -10, -12	JI, VI, VI48
M4A5-64/32	-7, -10, -12	JI, VI, VI48
M4A5-96/48		VI
M4A5-128/64		YI, VI
M4A5-192/96	-10, -12	VI
M4A5-256/128		YI, AI

Most MACH devices are dual-marked with both Commercial and Industrial grades. The Industrial speed grade is slower, i.e., M4A3-256/128-7YC-10YI

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local Lattice/Vantis sales office to confirm availability of specific valid combinations and to check on newly released combinations.

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